





TEST REPORT

REPORT NUMBER: 24B02W000008-005

ON

Type of Equipment:

Tracker

Type of Designation:

PT102V

Brand Name:

Prime

Manufacturer:

Micron Electronics LLC.

FCC ID:

ZKQ-PT102V

ACCORDING TO IEEE Std C95.1-2019 IEEE Std 1528-2013 PART 2.1093 Chongqing Academy of Information and Communication Technology

Month date, year Mar.22, 2024

Signature

Jin Zhou Director

Note:

The test results in this test report relate only to the devices specified in this report. This report shall not be reproduced except in full without the written approval of Chongqing Academy of Information and Communications Technology.





Revision Version

Report Number	Revision	Date	Memo
24B02W000008-005	00	2024-03-22	Initial creation of test report

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1.Test Laboratory

1.1 Testing Location

Name:	Chongqing Academy of Information and Communications Technology
Designation Number:	CN1239
Address:	Building C, Technology Innovation Center, No.8, Yuma Road, Chayuan New Area, Nan'an District, Chongqing, People's Republic of China
Postal Code:	401336
Telephone:	0086-23-88069965
Fax:	0086-23-88608777

1.2 Testing Environment

Normal Temperature:	18°C-25°C
Relative Humidity:	30%-70%
Ambient noise & Reflection:	< 0.012 W/kg

1.3 Project Data

Testing Start Date:	2024-3-8
Testing End Date:	2024-3-11

1.4 Signature

Hu Bo (Prepared this test report)

Yu Chun (Reviewed this test report)

Jin Zhou Director of the laboratory (Approved this test report) 2024-03-22

2024-03-22

Date

Date

2024-03-22

Date

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2. Statement of Compliance

The maximum results of Specific Absorption Rate (SAR) found during testing for Micron Electronics LLC. Tracker are as follow:

Table 2.1. Highest Reported SAR (19, W/Rg)		
Technology Band	Head	Body (5mm)
LTE Band4		1.27
LTE Band13		1.08

Table 2.1: Highest R	eported SAR	(1g,W/kg)

Remark: The SAR values found for the tracker are below the maximum recommended levels of 1.6 W/kg as averaged over any 1g tissue according to the IEEE Std C95.1TM-2019.

For body operation, this device has been tested and meets FCC RF exposure guidelines when used with any accessory that contains no metal and which provides a minimum separation distance of 5 mm between this device and the body of the user. Use of other accessories may not ensure compliance with FCC RF exposure guidelines.

The EUT battery must be fully charged and checked periodically during the test to ascertain uniform power output.

The measurement together with the test system set-up is described in Chapter 7 of this test report. A detailed description of the equipment under test can be found in Chapter 4 of this test report. The highest reported SAR value is obtained at the case of (Table 2.1), and the values are:

Body:1.27 W/kg (1g)





3.Client Information

3.1 Applicant Information

Company Name:	Micron Electronics LLC.
Address /Post:	1001 Yamato Road, Suite 400, Boca Raton, FL 33431, USA
City:	Boca Raton
Country:	USA
Telephone:	18875016586
Fax:	
Email:	pcheng@micron-electronics.com
Contact Person:	Ping Cheng

3.2 Manufacturer Information

Company Name:	Micron Electronics LLC.
Address /Post:	1001 Yamato Road, Suite 400, Boca Raton, FL 33431, USA
City:	Boca Raton
Country:	USA
Telephone:	18875016586
Fax:	
Email:	pcheng@micron-electronics.com
Contact Person:	Ping Cheng

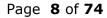




4. Equipment Under Test (EUT) and Ancillary Equipment (AE)

4.1 About EUT

Description:	Tracker
Model name:	PT102V
Brand name	Prime
LTE Frequency Band	4/13
Type of modulation	QPSK/16QAM
Extreme Temperature	-10/+60°C
Nominal Test Voltage	DC 3.8V
Extreme Test High Voltage	DC 4.2V
Extreme Test Low Voltage	DC 3.5V
Tested Tx Frequency:	1710–1755MHz (LTE Band 4)
	777–787 MHz (LTE Band 13)
Test device Production information:	Production unit
Device type:	Portable device
Antenna type:	Metal(internal) antenna
Hotspot mode:	Not support





4.2 Internal Identification of EUT used during the test

EUT ID*	SN or IMEI	HW Version	SW Version	Date of receipt	
24B02W000 008#S1	IMEI:866484030180649	PT102_V2_PCBA	PT102V03.01B07	2024-02-29	
24B02W000 008#S3	IMEI:66484030180723	PT102_V2_PCBA	PT102V03.01B07	2024-02-29	

*EUT ID: is used to identify the test sample in the lab internally.

4.3 Internal Identification of AE used during the test

AE ID*	Description	Model	SN	Manufacturer

*AE ID: is used to identify the test sample in the lab internally.





5.Reference Documents

5.1 Applicable Limit Regulations

IEEE Std C95.1-2019: IEEE Standard for Safety Levels with Respect to Human Exposure to Electric, Magnetic, and Electromagnetic Fields, 0 Hz to 300 GHz.

It specifies the maximum exposure limit of **1.6 W/kg** as averaged over any 1 gram of tissue for portable devices being used within 20 cm of the user in the uncontrolled environment.

5.2 Applicable Measurement Standards

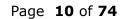
IEEE Std 1528-2013: Recommended Practice for Determining the Peak Spatial-Average Specific Absorption Rate (SAR) in the Human Body Due to Wireless Communications Devices: Experimental Techniques.

KDB447498 D01: General RF Exposure Guidance v06: Mobile and Portable Devices RF Exposure Procedures and Equipment Authorization Policies.

KDB941225 D05 SAR for LTE Devices v02r05: SAR Evaluation Considerations for LTE Devices

KDB865664 D01SAR measurement 100 MHz to 6 GHz v01r04: SAR Measurement Requirements for 100 MHz to 6 GHz.

KDB865664 D02 RF Exposure Reporting v01r02: RF Exposure Compliance Reporting and Documentation Considerations.





6.Specific Absorption Rate (SAR)

6.1 Introduction

SAR is related to the rate at which energy is absorbed per unit mass in an object exposed to a radio field. The SAR distribution in a biological body is complicated and is usually carried out by experimental techniques or numerical modeling. The standard recommends limits for two tiers of groups, occupational/controlled and general population/uncontrolled,based on a person's awareness and abilityto exercise control over his or her exposure.In general, occupational/controlled exposure limits are higher than the limits for general population/uncontrolled.

6.2 SAR Definition

The SAR definition is the time derivative (rate) of the incremental energy (dW) absorbed by (dissipated in) an incremental mass (dm) contained in a volume element (dv) of a given density (P). The equation description is as below:

$$SAR = \frac{d}{dt}(\frac{dW}{dm}) = \frac{d}{dt}(\frac{dW}{\rho dv})$$

SAR is expressed in units of Watts per kilogram (W/kg) SAR measurement can be either related to the temperature elevation in tissue by

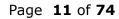
$$SAR = c(\frac{\delta T}{\delta t})$$

Where: C is the specific head capacity, δT is the temperature rise and δt is the exposure duration, or related to the electrical field in the tissue by

$$SAR = \frac{\sigma |E|^2}{\rho}$$

Where: σ is the conductivity of the tissue, ρ is the mass density of tissue and E is the RMS electrical field strength.

However for evaluating SAR of low power transmitter, electrical field measurement is typically applied.

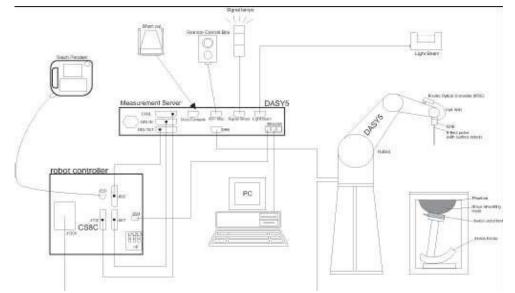




7.SAR MEASUREMENT SETUP

7.1 Measurement Set-up

The DASY5 system for performing compliance tests is illustrated above graphically. This system consists of the following items:



Picture 7.1-1 SAR Lab Test Measurement Set-up

- A standard high precision 6-axis robot (Stäubli TX=RX family) with controller, teach pendant and software. An arm extension for accommodating the data acquisition electronics (DAE).
- An isotropic field probe optimized and calibrated for the targeted measurement.
- A data acquisition electronics (DAE) which performs the signal amplification, signal multiplexing, AD-conversion, offset measurements, mechanical surface detection, collision detection, etc. The unit is battery powered with standard or rechargeable batteries. The signal is optically transmitted to the EOC.
- The Electro-optical converter (EOC) performs the conversion from optical to electrical signals for the digital communication to the DAE. To use optical surface detection, a special version of the EOC is required. The EOC signal is transmitted to the measurement server.
- The function of the measurement server is to perform the time critical tasks such as signal filtering, control of the robot operation and fast movement interrupts.
- The Light Beam used is for probe alignment. This improves the (absolute) accuracy of the probe positioning.
- A computer running WinXP and theDASY5 software.
- Remote control and teach pendant as well as additional circuitry for robot safety such as
- warning lamps, etc.
- The phantom, the device holder and other accessories according to the targeted measurement.

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7.2 DASY5 E-field Probe System

The SAR measurements were conducted with the dosimetric probe designed in the classical triangular configuration and optimized for dosimetric evaluation. The probe is constructed using the thick film technique; with printed resistive lines on ceramic substrates. The probe is equipped with an optical multifiber line ending at the front of the probe tip. It is connected to the EOC box on the robot arm and provides an automatic detection of the phantom surface. Half of the fibers are connected to a pulsed infrared transmitter, the other half to a synchronized receiver. As the probe approaches the surface, the reflection from the surface produces a coupling from the transmitting to the receiving fibers. This reflection increases first during the approach, reaches maximum and then decreases. If the probe is flatly touching the surface, the coupling is zero. The distance of the coupling maximum to the surface is independent of the surface reflectivity and largely independent of the surface to probe angle. The DASY5 software reads the reflection durning a software approach and looks for the maximum using 2ndord curve fitting. The approach is stopped at reaching the maximum.

Probe Specifications:

Model:	EX3DV4
Frequency:	650MHz — 6GHz
Calibration:	In head and body simulating tissue at Frequencies from 650 up to 4900MHz
Linearity:	$\pm 0.2 \mathrm{dB}$

Dynamic Range: 10mW/kg-100W/kg

Probe Length:330 mmProbe Tip Length:20mmBody Diameter:12 mm

Tip Diameter:2.5mmTip-Center :1 mm

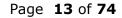
Application: SAR Dosimetry Test Compliance tests of trackers Dosimetry in strong gradient fields



Picture 7-2 Near-field Probe



Picture 7-3 E-field Probe





7.3 E-field Probe Calibration

Each E-Probe/Probe Amplifier combination has unique calibration parameters. A TEM cell calibration procedure is conducted to determine the proper amplifier settings to enter in the probe parameters. The amplifier settings are determined for a given frequency by subjecting the probe to a known E-field density (1 mW/cm²) using an RF Signal generator, TEM cell, and RF Power Meter.

The free space E-field from amplified probe outputs is determined in a test chamber. This calibration can be performed in a TEM cell if thefrequency is below 1 GHz and inn a waveguide or other methodologies above 1 GHz for free space. For the free space calibration, the probe is placed in the volumetric center of the cavity and at the proper orientation with the field. The probe is then rotated 360 degrees until the three channels show the maximum reading. The power density readings equates to 1 mW/ cm^2 .

E-field temperature correlation calibration is performed in a flat phantom filled with the appropriate simulated brain tissue. The E-field in the medium correlates with the temperature rise in the dielectric medium. For temperature correlation calibration a RF transparent thermistor-based temperature probe is used in conjunction with the E-field probe.

$$SAR = C \frac{\Delta T}{\Delta t}$$

Where:

 $\Delta t = Exposure time (30 seconds),$

C = Heat capacity of tissue (brain or muscle),

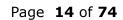
 ΔT = Temperature increase due to RF exposure.

$$SAR = \frac{\left|E\right|^2 \cdot \sigma}{\rho}$$

Where:

 σ = Simulated tissue conductivity,

 ρ = Tissue density (kg/m³).





7.4 Other Test Equipment

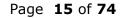
7.4.1 Data Acquisition Electronics(DAE)

The data acquisition electronics consist of a highly sensitive electrometer-grade preamplifier with

auto-zeroing, a channel and gain-switching multiplexer, a fast 16 bit AD-converter and a command decoder with a control logic unit. Transmission to the measurement server is accomplished through an optical downlink for data and status information, as well as an optical uplink for commands and the clock. The mechanical probe mounting device includes two different sensor systems for frontal and sideways probe contacts. They are used for mechanical surface detection and probe collision detection. The input impedance of the DAE is 200 MOhm; the inputs are symmetrical and floating. Common mode rejection is above 80 dB.



Picture7.4.1-1: DAE





7.4.2 Robot

The SPEAG DASY system uses the high precision robots (DASY5: TX90) type from Stäubli SA (France). For the 6-axis controller system, the robot controller version from Stäubli is used. The Stäubli robot series have many features that are important for our application:

- High precision (repeatability 0.02mm)
- High reliability (industrial design)
- > Low maintenance costs (virtually maintenance free due to direct drive gears; no belt drives)
- > Jerk-free straight movements (brushless synchron motors; no stepper motors)
- > Low ELF interference (motor control fields shielded via the closed metallic construction shields)



Picture7.4.2-1: DASY 5





7.4.3 Measurement Server

The Measurement server is based on a PC/104 CPU broad with CPU (DASY5: 400 MHz, Intel Celeron), chipdisk (DASY5: 128MB), RAM (DASY5: 128MB). The necessary circuits for communication with the DAE electronic box, as well as the 16 bit AD converter system for optical detection and digital I/O interface are contained on the DASY I/O broad, which is directly connected to the PC/104 bus of the CPU broad.

The measurement server performs all real-time data evaluation of field measurements and surface detection, controls robot movements and handles safety operation. The PC operating system cannot interfere with these time critical processes. All connections are supervised by a watchdog, and disconnection of any of the cables to the measurement server will automatically disarm the robot and disable all program-controlled robot movements. Furthermore, the measurement server is equipped with an expansion port which is reserved for future applications. Please note that this expansion port does not have a standardized pinout, and therefore only devices provided by SPEAG can be connected. Devices from any other supplier could seriously damage the measurement server.



Picture 7.4.3-1: Server for DASY 5

7.4.4 Device Holder for Phantom

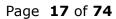
The SAR in the phantom is approximately inversely proportional to the square of the distance between the source and the liquid surface. For a source at 5mm distance, a positioning uncertainty of ± 0.5 mm would produce a SAR uncertainty of $\pm 20\%$. Accurate device positioning is therefore crucial for accurate and repeatable measurements. The positions in which the devices must be measured are defined by the standards.

The DASY device holder is designed to cope with the different positions given in the standard. It has two scales for device rotation (with respect to the body axis) and device inclination (with respect to the line between the ear reference points). The rotation centers for both scales is the ear reference point (ERP). Thus the device needs no repositioning when changing the angles. The DASY device holder is constructed of low-loss POM material having the following dielectric parameters:

relative permittivity=3 and loss tangent=0.02. The amount of dielectric material has been reduced in the closest vicinity of the device, since measurements have suggested that the influence of the clamp on the test results could thus be lowered.

<Laptop Extension Kit>

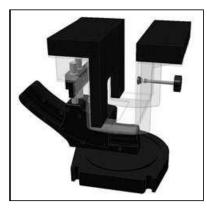
The extension is lightweight and made of POM, acrylic glass and foam. It fits easily on the upper part of the Mounting Device in place of the phone positioner. The extension is fully compatible with the Twin-SAM and ELI phantoms.







Picture7.4.4-1: Device Holder



Picture 7.4.4-2: Laptop Extension Kit

7.4.5 Phantom

The SAM Twin Phantom V4.0 is constructed of a fiberglass shell integrated in a table. The shape of the shell is based on data from an anatomical study designed to

Represent the 90th percentile of the population. The phantom enables the dissymmetric evaluation of SAR for both left and right handed handset usage, as well as body-worn usage using the flat phantom region. Reference markings on the Phantom allow the complete setup of all predefined phantom positions and measurement grids by manually teaching three points in the robot. The shell phantom has a 2mm shell thickness (except the ear region where shell thickness increases to 6 mm).

Shell Thickness: $2 \pm 0.2 \text{ mm}$

Filling Volume:Approx. 25 litersDimensions:810 x 1000 x 500 mm (H x L x W)

Available: Special



Picture 7.4.5-1: SAM Twin Phantom

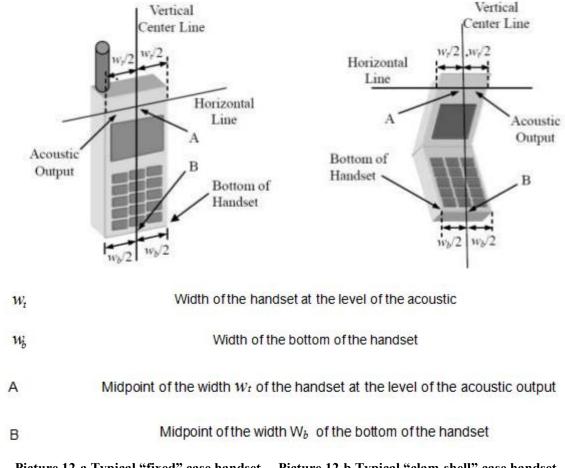




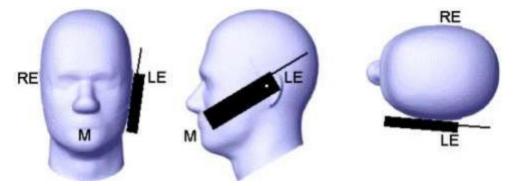
8.Position of the wireless device in relation to the phantom

8.1 General considerations

This standard specifies two handset test positions against the head phantom – the "cheek" position and the "tilt" position.



Picture 12-a Typical "fixed" case handset Picture 12-b Typical "clam-shell" case handset

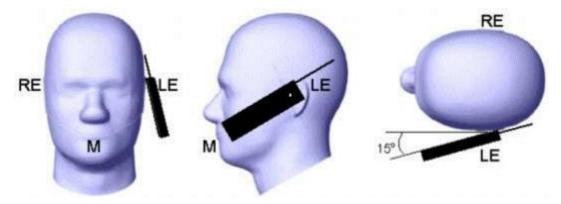


Picture 8.1-1 Cheek position of the wireless device on the left side of SAM

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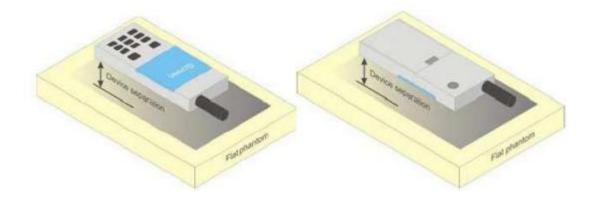




Picture 8.1-2 Tilt position of the wireless device on the left side of SAM

8.2 Body-worn device

A typical example of a body-worn device is a tracker, wireless enabled PDA or other battery operated wireless device with the ability to transmit while mounted on a person's body using a carry accessory approved by the wireless device manufacturer.



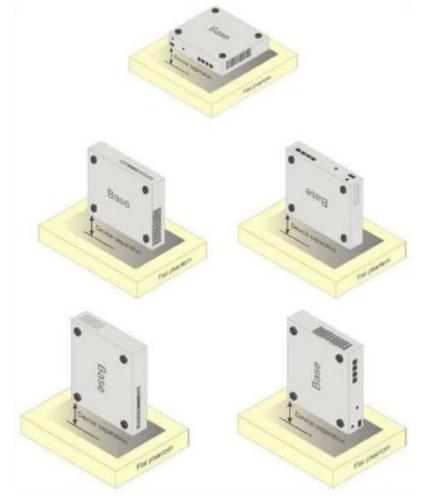
Picture 8.2-1 Test positions for body-worn devices





8.3 Desktop device

A typical example of a desktop device is a wireless enabled desktop computer placed on a table or desk when used. The DUT shall be positioned at the distance and in the orientation to the phantom that corresponds to the intended use as specified by the manufacturer in the user instructions. For devices that employ an external antenna with variable positions, tests shall be performed for all antenna positions specified. Picture16 show positions for desktop device SAR tests. If the intended use is not specified, the device shall be tested directly against the flat phantom.



Picture8.3-1 Test positions for desktop devices





8.4 DUT Setup Photo



Picture 8.4-1: Specific Absorption Rate Test Layout





9. Tissue Simulating Liquids

9.1 Equivalent Tissues

The liquid used for the frequency range of 800-3000 MHz consisted of water, sugar, salt and Cellulose. The liquid has been previously proven to be suited for worst-case. The Table 9.1-1 and 9.1-2 shows the detail solution. The following tissue formulations are provided for reference only as some of the parameters have not been thoroughly verified. The composition of ingredients may be modified accordingly to achieve the desired target tissue parameters required for routine SAR evaluation.

Tuble 711 1 Composition of the Head Hisbue Equivalent it							
Ingredients (% by weight)							
Frequency (MHz)	835MHz	1750MHz					
water	41.45	55.24					
sugar	56.00	/					
salt	1.45	0.306					
preventol	0.1	/					
cellulose	1.0	/					
ClycolMonobutyl	/	44.45					
Dialactria Daramatara	f=835MHz	f=1750MHz					
Dielectric Parameters	ε=41.555	ε=40.079					
Target Value	σ=0.910	σ=1.371					

Table 9.1-1 Composition of the Head Tissue Equivalent Matter

Frequency (MHz)	Liquid Type	Conductivity (σ)	± 5% Range	Permittivity (ε)	± 5% Range
835	Head	0.910	0.865~0.956	41.555	39.477~43.632
1750	Head	1.371	1.302~1.440	40.079	38.075~42.083

Table 9.1-2 Targets for tissue simulating liquid

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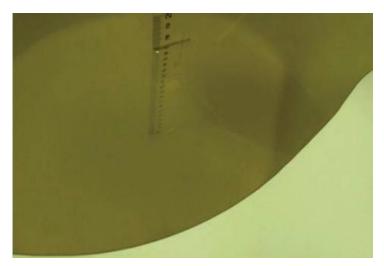
9.2 Dielectric Performance

Measurement Value								
Liquid Temperature: 22.1°C								
Туре	Frequency (MHz)	Permittivity E	Drift (%)	Conductivity σ	Drift (%)	Test Date		
Head	835	43.156	3.85	0.915	0.55	2024-3-8		
Head	1750	41.103	2.55	1.361	-0.73	2024-3-11		

Table 9.2-1: Dielectric Performance of Head Tissue Simulating Liquid



Picture 9.2-1: Liquid depth in the Flat Phantom (Head 835 MHz)



Picture 9.2-2: Liquid depth in the Flat Phantom (Head 1750 MHz)





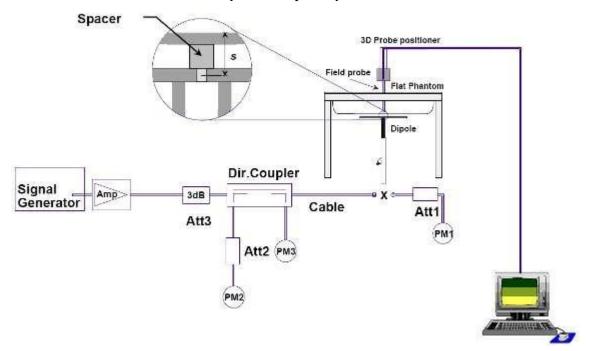
10.System Validation

10.1 System Validation

Each DASY system is equipped with one or more system validation kits. These units, together with the predefined measurement procedures within the DASY software, enable the user to conduct the system performace check and system validation. System validation kit includes a dipole, tripod holder to fix it underneath the flat phantom and a corresponding distance holder.

10.2 System Setup

In the simplified setup for system evaluation, the DUT is replaced by a calibrated dipole and the power source is replaced by a continuous wave that comes from a signal generator. The calibrated dipole must be placed beneath the flat phantom section of the SAM twin phantom with the correct distance holder. The distance holder should touch the phantom surface with a light pressure at the reference marking and be oriented parallel to the long side of the phantom. The equipment setup is shown below:

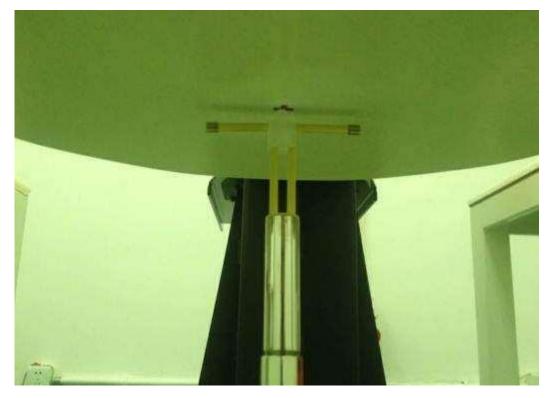


Picture 10.2-1 System Setup for System Evaluation

The output power on dipole port must be calibrated to 24 dBm (250mW) before dipole is connected. The results are normalized to 1 W input power.







Picture 10.2-1: Photo of Dipole Setup

Verification Results									
Input power level: 1W									
	Target va	lue (W/kg)	Measured value (W/kg) Deviation		xg) Deviation				
Frequency	1 g Average	10 g Average	1 g Average	10 g Average	1 g Average(%)	10 g Average(%)	Test date		
835MHz	2.41	1.56	2.32	1.52	-3.73%	-2.56%	2024-3-8		
1750MHz	9.01	4.77	8.63	4.73	-4.22%	-0.84%	2024-3-11		

Table	10.2-1:	S	vstem	v	alidation	of	Head
1 ant	10.4-1		stem	•	anuation	UI	IItau





11. Measurement Procedures

11.1 Tests to be performed

In order to determine the highest value of the peak spatial-average SAR of a handset, all device positions, configurations and operational modes shall be tested for each frequency band according to steps 1 to 3 below. A flowchart of the test process is shown in Picture 19

Step 1: The tests described in 11.2 shall be performed at the channel that is closest to the centre of the transmit frequency band (f_c) for:

a) all device positions (cheek and tilt, for both left and right sides of the SAM phantom, as described in Chapter 8),

b) all configurations for each device position in a), e.g., antenna extended and retracted, and

c) all operational modes, e.g., analogue and digital, for each device position in a) and configuration in b) in each frequency band.

If more than three frequencies need to be tested according to 11.1 (i.e., $N_c > 3$), then all frequencies,

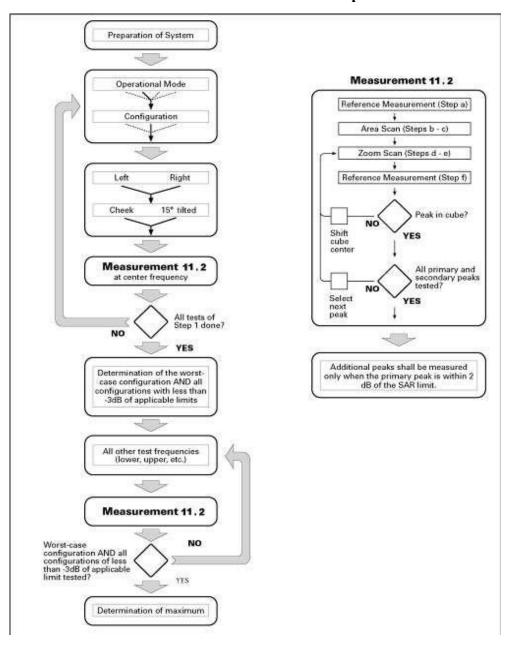
configurations and modes shall be tested for all of the above test conditions.

Step 2: For the condition providing highest peak spatial-average SAR determined in Step 1, perform all tests described in 11.2 at all other test frequencies, i.e., lowest and highest frequencies. In addition, for all other conditions (device position, configuration and operational mode) where the peak spatial-average SAR value determined in Step 1 is within 3 dB of the applicable SAR limit, it is recommended that all other test frequencies shall be tested as well.

Step 3: Examine all data to determine the highest value of the peak spatial-average SAR found in Steps 1 to 2.







Picture 11.1-1: Block diagram of the tests to be performed





11.2 Measurement procedure

The following procedure shall be performed for each of the test conditions (see Picture 19) described in 11.1:

a) Measure the local SAR at a test point within 8 mm or less in the normal direction from the inner surface of the phantom.

b) Measure the two-dimensional SAR distribution within the phantom (area scan procedure). The boundary of the measurement area shall not be closer than 20 mm from the phantom side walls. The distance between the measurement points should enable the detection of the location of local maximum with an accuracy of better than half the linear dimension of the tissue cube after interpolation. A maximum grip spacing of 20 mm for frequencies below 3 GHz and (60/f [GHz]) mm for frequencies of 3GHz and greater is recommended. The maximum distance between the geometrical centre of the probe detectors and the inner surface of the phantom shall be 5 mm for frequencies below 3 GHz and $\delta In(2)/2$ mm for frequencies of 3 GHz and greater, where δI the plane wave skin depth and In(x) is the natural logarithm. The maximum variation of the sensor-phantom surface shall be ± 1 mm for frequencies below 3 GHz and ± 0.5 mm for frequencies of 3 GHz and greater. At all measurement points the angle of the probe with respect to the line normal to the surface should be less than 5°. If this cannot be achieved for a measurement distance to the phantom inner surface shorter than the probe diameter, additional uncertainty evaluation is needed.

c) From the scanned SAR distribution, identify the position of the maximum SAR value, in addition identify the positions of any local maxima with SAR values within 2 dB of the maximum value that are not within the zoom-scan volume; additional peaks shall be measured only when the primary peak is within 2 dB of the SAR limit. This is consistent with the 2 dB threshold already stated;

d) Measure the three-dimensional SAR distribution at the local maxima locations identified in step





e) The horizontal grid step shall be (24 / f[GHz]) mm or less but not more than 8 mm. The minimum zoom size of 30 mm by 30 mm and 30 mm for frequencies below 3 GHz. For higher frequencies, the minimum zoom size of 22 mm by 22 mm and 22 mm. The grip step in the vertical direction shall be (8-f[GHz]) mm or less but not more than 5 mm, if uniform spacing is used. If variable spacing is used in the vertical direction, the maximum spacing between the two closest measured points to the phantom shell shall be (12 / f[GHz]) mm or less but not more than 4 mm, and the spacing between father points shall increase by an incremental factor not exceeding 1.5. When variable spacing is used, extrapolation routines shall be tested with the same spacing as used in measurements. The maximum distance between the geometrical centre of the probe detectors and the inner surface of the phantom shall be 5 mm for frequencies below 3 GHz and $\delta \ln(2)/2$ mm for frequencies of 3 GHz and greater, where δ is the plane wave skin depth and $\ln(x)$ is the natural logarithm. Separate grids shall be centered on each of the local SAR maxima found in step c). Uncertainties due to field distortion between the media boundary and the dielectric enclosure of the probe should also be minimized, which is achieved is the distance between the phantom surface and physical tip of the probe is larger than probe tip diameter. Other methods may utilize correction procedures for these boundary effects that enable high precision measurements closer than half the probe diameter. For all measurement points, the angle of the probe with respect to the flat phantom surface shall be less than 5°. If this cannot be achieved an additional uncertainty evaluation is needed.

f) Use post processing(e.g. interpolation and extrapolation) procedures to determine the local SAR values at the spatial resolution needed for mass averaging.





11.3 SAR Measurement for LTE

SAR tests for LTE are performed with a base station simulator, Rohde & Rchwarz CMW500. Closed loop power control was used so the UE transmits with maximum output power during SAR testing. All powers were measured with the CMW 500.

It is performed for conducted power and SAR based on the KDB941225 D05.

SAR is evaluated separately according to the following procedures for the different test positions in each exposure condition – head, body, body-worn accessories and other use conditions. The procedures in the following subsections are applied separately to test each LTE frequency band.

1) QPSK with 1 RB allocation

Start with the largest channel bandwidth and measure SAR for QPSK with 1 RB allocation, using the RB offset and required test channel combination with the highest maximum output power among RB offsets at the upper edge, middle and lower edge of each required test channel. When the reported SAR is ≤ 0.8 W/kg, testing of the remaining RB offset configurations and required test channels is not required for 1 RB allocation; otherwise, SAR is required for the remaining required test channels and only for the RB offset configuration with the highest output power for that channel. When the reported SAR of a required test channel is > 1.45 W/kg, SAR is required for all three RB offset configurations for that required test channel.

2) QPSK with 50% RB allocation

The procedures required for 1 RB allocation in 1) are applied to measure the SAR for QPSK with 50% RB allocation.

3) QPSK with 100% RB allocation

For QPSK with 100% RB allocation, SAR is not required when the highest maximum output power for 100 % RB allocation is less than the highest maximum output power in 50% and 1 RB allocations and the highest reported SAR for 1 RB and 50% RB allocation in 1) and 2) are ≤ 0.8 W/kg. Otherwise, SAR is measured for the highest output power channel; and if the reported SAR is > 1.45 W/kg, the remaining required test channels must also be tested.

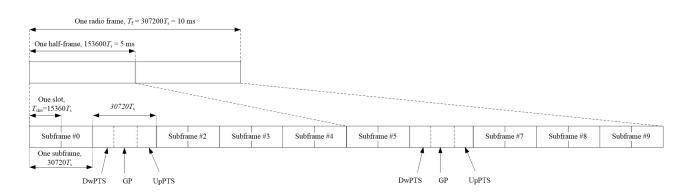
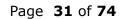


Figure 11.3-1: Frame structure type 2 (for 5 ms switch-point periodicity)

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	N	Normal cyclic prefix in downlink			Extended cyclic prefix in downlink			
Special	DwPTS	UpP	ГS	DwPTS	DwPTS UpPTS			
subframe configuration		Normal cyclic prefix in uplink	Extended cyclic prefix in uplink		Normal cyclic prefix in uplink	Extended cyclic prefix in uplink		
0	$6592 \cdot T_{\rm s}$			$7680 \cdot T_s$				
1	$19760 \cdot T_s$		2560 · T _s	$20480 \cdot T_s$	$2192 \cdot T_{\rm s}$	$2560 \cdot T_{s}$		
2	$21952 \cdot T_s$	$2192 \cdot T_{\rm s}$		$23040 \cdot T_s$				
3	24144 $\cdot T_s$			$25600 \cdot T_s$				
4	$26336 \cdot T_s$			$7680 \cdot T_{\rm s}$				
5	$6592 \cdot T_s$			$20480 \cdot T_s$	1201 T	5120 T		
6	$19760 \cdot T_s$			$23040 \cdot T_s$	$4384 \cdot T_{s}$	$5120 \cdot T_{\rm s}$		
7	21952 $\cdot T_s$	$4384 \cdot T_s$	$5120 \cdot T_{\rm s}$	$12800 \cdot T_s$				
8	24144 $\cdot T_s$			-	-	-		
9	$13168 \cdot T_s$			-	-	-		

Table 11.3-1: Configuration of special subframe (lengths of DwPTS/GP/UpPTS)

Uplink-	Downlink-to-Uplink		Subframe number								
downlink configuration	Switch-point periodicity	0	1	2	3	4	5	6	7	8	9
0	5 ms	D	S	U	U	U	D	S	U	U	U
1	5 ms	D	S	U	U	D	D	S	U	U	D
2	5 ms	D	S	U	D	D	D	S	U	D	D
3	10 ms	D	S	U	U	U	D	D	D	D	D
4	10 ms	D	S	U	U	D	D	D	D	D	D
5	10 ms	D	S	U	D	D	D	D	D	D	D
6	5 ms	D	S	U	U	U	D	S	U	U	D

Duty factor is calculated by:

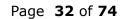
Duty factor = uplink frame*6+UpPTS*2/one frame length

= (30720.Ts * 6+5120. Ts*2)/307200.Ts

= 0.633

11.4 Power Drift

To control the output power stability during the SAR test, DASY5 system calculates the power drift by measuring the E-field at the same location at the beginning and at the end of the measurement for each test position. These drift values can be found in Section 15 labeled as: (Power Drift [dB]). This ensures that the power drift during one measurement is within 5%.





12.Area Scan Based 1-g SAR

12.1 Requirement of KDB

According to the KDB447498D01v05, when the implementation is based the specific polynomial it algorithm as presented at the 29th Bioelectromagnetics Society meeting (2007) and the estimated 1-g SARis≤1.2W/kg, a zoom scan measurement is not required provided it is also not needed For any other purpose ;for example, if the peak SAR location required for simultaneous transmission SAR test exclusion can be determined accurately by the SAR system or manually to discriminate between is tinctive peak sand scattered noisy SAR distributions from area scans.

There must not be any warning or alert messages due to various measurement concerns identified by the SAR system; for example, noise in measurements ,peaks too close to scan boundary, peaks are too sharp, spatial resolution and uncertainty issues etc. The SAR system verification must also demonstrate that the area scan estimated 1-gSAR is within 3% of the zoom scan 1-g SAR (See Annex A). When all the SAR results for each exposure condition in a frequency band and wireless mode are based on estimated 1-g SAR, the 1-g SAR for the highest SAR configuration must be determined by a zoom scan.

12.2 Fast SAR Algorithms

The approach is based on the area scan measurement applying a frequency dependent attenuation parameter. This attenuation parameter was empiri call determined by analyzing a large number of phones. The MOTOROLAFASTSAR was developed and validated by the MOTOROLA Research Group in Ft .Lauderdale.

In the initial study, an approximation algorithm based on Linearf it was developed. The accuracy of the algorithm has been demonstrated across abroad frequency range(136-2450 MHz)andforboth1-gand 10-g averaged SAR using a sample of 264SARmeasurementsfrom55 wireless handsets. For the sample size studied, the root-mean-squared errors of the algorithmare1.2% and 5.8% for1-g and 10-g averaged SAR, respectively. The paper describing the algorith min detail is expected to be published inAugust2004 within the Special Issue of Transactions on MTT.

In the second step, the same research group optimized the fitting algorithm to an Polynomia lf it where by the frequency validity was extended to cover the range 30-6000MHz.Detailsof this study can be found in the BEMS2007 Proceedings.Both algorithms are implemented in DASY software.





13.Conducted Output Power

13.1 LTE Measurement Result

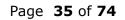
Maximum Target Power for Production Unit						
	Frequency Band	Tune up (dBm)				
Band 4	16QAM&QPSK	23.8±2				
Band 13	16QAM&QPSK	24.5±2				







		LTE band4		
BANDWIDTH	Number of RBs	Frequency	QPSK	16QAM
		1710.7(19957)	25.57	24.43
	1RB-High (5)	1732.5 (20175)	25.25	24.52
1.4MHz		1754.3(20393)	25.33	24.12
	1RB-Middle (3)	1710.7(19957)	25.72	24.49
		1732.5 (20175)	25.37	24.62
		1754.3(20393)	25.10	24.28
	1RB-Low (0)	1710.7(19957)	25.57	24.45
		1732.5 (20175)	25.36	24.52
		1754.3(20393)	24.97	24.05
	3RB-High (3)	1710.7(19957)	25.35	24.74
		1732.5 (20175)	25.46	25.35
		1754.3(20393)	25.21	25.03
	3RB-Middle (1)	1710.7(19957)	25.33	24.10
		1732.5 (20175)	25.44	24.10
		1754.3(20393)	25.18	24.12
		1710.7(19957)	25.51	24.92
	3RB-Low (0)	1732.5 (20175)	25.21	25.28
	JKD-LOW (0)	· · · · · · · · · · · · · · · · · · ·	25.26	25.16
		1754.3(20393)	25.20	23.10
	(DD (0)	1710.7(19957)	24.19	22.89
	6RB (0)	1732.5 (20175)		
		1754.3(20393)	24.09	22.95
	1DD 11:-1. (14)	1711.5(19965)	24.78	23.42
	1RB-High (14)	1732.5 (20175)	25.10	23.96
		1753.5(20385)	25.12	24.10
		1711.5(19965)	25.06	23.83
	1RB-Middle (7)	1732.5 (20175)	25.14	23.93
		1753.5(20385)	25.05	24.19
3MHz		1711.5(19965)	25.21	23.87
	1RB-Low (0)	1732.5 (20175)	25.14	23.92
		1753.5(20385)	24.89	23.95
	8RB-High (7)	1711.5(19965)	24.71	24.44
		1732.5 (20175)	25.25	25.13
		1753.5(20385)	24.87	24.83
	8RB-Middle (4)	1711.5(19965)	23.85	22.70
		1732.5 (20175)	24.05	22.94
		1753.5(20385)	23.80	22.83
	8RB-Low (0)	1711.5(19965)	24.68	24.58
		1732.5 (20175)	25.15	24.94
		1753.5(20385)	24.89	25.12
	15RB (0)	1711.5(19965)	23.89	22.71
		1732.5 (20175)	23.99	23.23
		1753.5(20385)	23.80	22.53
5MHz	1RB-High (24)	1712.5(19975)	24.99	23.54
		1732.5 (20175)	24.90	24.04
		1752.5(20375)	25.00	24.09
	1RB-Middle (12)	1712.5(19975)	24.99	23.50
		1732.5 (20175)	24.97	24.18
		1752.5(20375)	25.04	23.91
	1RB-Low (0)	1712.5(19975)	24.99	23.85
		1732.5 (20175)	25.06	24.13







		1752.5(20375)	24.84	23.85
		1712.5(19975)	23.81	22.52
	12RB-High (13)	1732.5 (20175)	24.00	22.87
		1752.5(20375)	24.02	22.93
		1712.5(19975)	23.83	22.73
	12RB-Middle (6)	1732.5 (20175)	23.89	22.86
		1752.5(20375)	23.90	22.61
	12RB-Low (0)	1712.5(19975)	23.78	22.88
		1732.5 (20175)	23.87	22.95
		1752.5(20175)	23.81	22.82
	25RB (0)	1712.5(19975)	23.82	22.68
		1732.5 (20175)	23.91	22.89
		· · · · · ·	23.86	22.83
		1752.5(20375)		
	1RB-High (49)	1715(20000)	24.76	
		1732.5 (20175)	24.92	
		1750(20350)	25.19	
		1715(20000)	25.17	
	1RB-Middle (24)	1732.5 (20175)	25.11	
		1750(20350)	25.14	
		1715(20000)	24.93	
	1RB-Low (0)	1732.5 (20175)	24.87	
		1750(20350)	25.02	
		1715(20000)	23.89	
10MHz	25RB-High (25)	1732.5 (20175)	23.99	
		1750(20350)	23.99	
		1715(20000)	23.87	
	25RB-Middle (12)	1732.5 (20175)	23.97	
		1750(20350)	23.99	
		1715(20000)	23.95	
	25RB-Low (0)	1732.5 (20175)	23.96	
	23KD-LOW (0)	1750(20350)	23.97	
	50RB (0)	1715(20000)	23.82	
		1732.5 (20175)	23.97	
			23.97	
		1750(20350)		
		1717.5(20025)	24.79	
		1732.5 (20175)	24.95	
		1747.5(20325)	24.92	
		1717.5(20025)	24.86	
	1RB-Middle (37)	1732.5 (20175)	24.98	
		1747.5(20325)	24.80	
		1717.5(20025)	24.87	
	1RB-Low (0)	1732.5 (20175)	24.88	
151/11-		1747.5(20325)	25.10	
15MHz	36RB-High (39)	1717.5(20025)	23.84	
		1732.5 (20175)	23.84	
		1747.5(20325)	23.67	
	36RB-Middle (19)	1717.5(20025)	23.81	
		1732.5 (20175)	23.94	
		1747.5(20325)	23.82	
	36RB-Low (0)	1717.5(20025)	23.83	
		1732.5 (20175)	23.03	
		· · · · · ·		
		1747.5(20325)	23.93	







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1717.5(20025) 23.76 75RB (0) 1732.5 (20175) 23.83 1747.5(20325) 23.83 1747.5(20325) 23.83 1747.5(20325) 23.83 1747.5(20325) 23.83 178B (0) 1745(20300) 24.99 1745(20300) 24.75 1745(20300) 24.75 1RB-Middle (49) 1732.5 (20175) 25.03 1RB-Middle (49) 1732.5 (20175) 25.33 1RB-Low (0) 1732.5 (20175) 24.64 1RB-Low (0) 1732.5 (20175) 24.64 1RB-Low (0) 1732.5 (20175) 24.84 1745(20300) 24.97 1720(20050) 23.88 1745(20300) 24.16 50RB-Middle (25) 1732.5 (20175) 24.28					
$20MHz = \begin{bmatrix} 1747.5(20325) & 23.83 & \\ 1747.5(20325) & 24.83 & \\ 1720(20050) & 24.99 & \\ 1732.5(20175) & 24.62 & \\ 1745(20300) & 24.75 & \\ 1720(20050) & 25.03 & \\ 1720(20050) & 25.03 & \\ 1720(20050) & 24.96 & \\ 1720(20050) & 24.96 & \\ 1720(20050) & 24.69 & \\ 1720(20050) & 24.64 & \\ 1720(20050) & 24.64 & \\ 1745(20300) & 24.97 & \\ 1720(20050) & 23.88 & \\ 1720(20050) & 23.88 & \\ 1720(20050) & 23.88 & \\ 1720(20050) & 23.88 & \\ 1720(20050) & 23.88 & \\ 1720(20050) & 23.88 & \\ 1720(20050) & 23.88 & \\ 1720(20050) & 24.16 & \\ 1745(20300) & 24.16 & \\ 1745(20300) & 24.18 & \\ 1745(20300) & 24.18 & \\ 1720(20050) & 23.73 & \\ 50RB-Middle (25) & 1732.5(20175) & 23.95 & \\ 1745(20300) & 24.01 & \\ 1720(20050) & 24.01 & \\ 100RB (0) & 1732.5(20175) & 24.50 & \\ \end{bmatrix}$			1717.5(20025)	23.76	
$20 \text{MHz} \begin{array}{ c c c c c c c c c c c c c c c c c c c$		75RB (0)	1732.5 (20175)	23.83	
$20MHz = \begin{bmatrix} 1RB-High (99) & 1732.5 (20175) & 24.62 & \\ 1745(20300) & 24.75 & \\ 1720(20050) & 25.03 & \\ 1720(20050) & 25.03 & \\ 1720(20050) & 24.96 & \\ 1745(20300) & 24.96 & \\ 1720(20050) & 24.69 & \\ 1745(20300) & 24.64 & \\ 1745(20300) & 24.97 & \\ 1745(20300) & 24.97 & \\ 1720(20050) & 23.88 & \\ 1720(20050) & 23.88 & \\ 1745(20300) & 23.82 & \\ 1745(20300) & 23.82 & \\ 1745(20300) & 23.82 & \\ 1745(20300) & 23.82 & \\ 1745(20300) & 24.16 & \\ 1745(20300) & 24.16 & \\ 1745(20300) & 24.18 & \\ 1745(20300) & 24.18 & \\ 1720(20050) & 23.73 & \\ 1745(20300) & 24.18 & \\ 1720(20050) & 23.73 & \\ 1745(20300) & 24.01 & \\ 1745(20300) & 24.01 & \\ 100RB (0) & 1732.5 (20175) & 24.50 & \\ \end{bmatrix}$			1747.5(20325)	23.83	
$20MHz = \begin{array}{c c c c c c c c c c c c c c c c c c c $			1720(20050)	24.99	
$20MHz = \begin{bmatrix} 1720(20050) & 25.03 & \\ 1RB-Middle (49) & 1732.5 (20175) & 25.33 & \\ 1745(20300) & 24.96 & \\ 1745(20300) & 24.69 & \\ 1720(20050) & 24.69 & \\ 1745(20300) & 24.97 & \\ 1745(20300) & 24.97 & \\ 1745(20300) & 23.88 & \\ 1720(20050) & 23.88 & \\ 1745(20300) & 23.82 & \\ 1745(20300) & 23.82 & \\ 1745(20300) & 23.82 & \\ 1745(20300) & 24.16 & \\ 1745(20300) & 24.16 & \\ 1745(20300) & 24.18 & \\ 1745(20300) & 24.18 & \\ 1745(20300) & 24.18 & \\ 1745(20300) & 24.18 & \\ 1745(20300) & 24.18 & \\ 1745(20300) & 24.18 & \\ 1745(20300) & 24.18 & \\ 1745(20300) & 24.18 & \\ 1745(20300) & 24.18 & \\ 1745(20300) & 24.18 & \\ 1745(20300) & 24.01 & \\ 1745(20300) & 24.01 & \\ 1745(20300) & 24.00 & \\ 1720(20050) & 24.00 & \\ 100RB (0) & 1732.5 (20175) & 24.50 & \\ \end{bmatrix}$		1RB-High (99)	1732.5 (20175)	24.62	
$\begin{array}{c c c c c c c c c c c c c c c c c c c $			1745(20300)	24.75	
$20 \text{MHz} \begin{array}{ c c c c c c c c c c c c c c c c c c c$			1720(20050)	25.03	
$\begin{array}{c cccccc} & 1720(20050) & 24.69 & \\ \hline 1RB-Low (0) & 1732.5 (20175) & 24.64 & \\ \hline 1745(20300) & 24.97 & \\ \hline 1745(20300) & 23.88 & \\ \hline 1720(20050) & 23.88 & \\ \hline 1745(20300) & 23.82 & \\ \hline 1745(20300) & 23.82 & \\ \hline 1745(20300) & 24.16 & \\ \hline 50RB-Middle (25) & 1732.5 (20175) & 24.28 & \\ \hline 1745(20300) & 24.18 & \\ \hline 1745(20300) & 24.18 & \\ \hline 1745(20300) & 24.18 & \\ \hline 1745(20300) & 23.73 & \\ \hline 1745(20300) & 24.01 & \\ \hline 1745(20300) & 24.01 & \\ \hline 100RB (0) & 1732.5 (20175) & 24.50 & \\ \end{array}$		1RB-Middle (49)	1732.5 (20175)	25.33	
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$			1745(20300)	24.96	
$20 \text{MHz} \qquad \begin{array}{ c c c c c c c c } \hline & & & & & & & & & & & & & & & & & & $			1720(20050)	24.69	
$\begin{array}{c ccccc} 20 \text{MHz} & \begin{array}{c} & 1720(20050) & 23.88 & \\ & 50 \text{RB-High} (50) & 1732.5 (20175) & 23.84 & \\ & 1745(20300) & 23.82 & \\ & 1745(20300) & 24.16 & \\ & 50 \text{RB-Middle} (25) & 1732.5 (20175) & 24.28 & \\ & 1745(20300) & 24.18 & \\ & 1745(20300) & 23.73 & \\ & 50 \text{RB-Low} (0) & 1732.5 (20175) & 23.95 & \\ & 1745(20300) & 24.01 & \\ & 1745(20300) & 24.01 & \\ & 1720(20050) & 24.00 & \\ & 100 \text{RB} (0) & 1732.5 (20175) & 24.50 & \end{array}$		1RB-Low (0)	1732.5 (20175)	24.64	
$\begin{array}{c c c c c c c c c c c c c c c c c c c $			1745(20300)	24.97	
$\begin{array}{ c c c c c c c c c c c c c c c c c c c$			1720(20050)	23.88	
$ \begin{array}{c ccccc} & 1720(20050) & 24.16 & \\ \hline 50 \text{RB-Middle} (25) & 1732.5 (20175) & \textbf{24.28} & \\ \hline 1745(20300) & 24.18 & \\ \hline 1745(20050) & 23.73 & \\ \hline 50 \text{RB-Low} (0) & 1732.5 (20175) & 23.95 & \\ \hline 1745(20300) & 24.01 & \\ \hline 1745(20300) & 24.01 & \\ \hline 100 \text{RB} (0) & 1732.5 (20175) & 24.50 & \\ \hline \end{array} $	20MHz	50RB-High (50)	1732.5 (20175)	23.84	
$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$			1745(20300)	23.82	
1745(20300) 24.18 1720(20050) 23.73 50RB-Low (0) 1732.5 (20175) 23.95 1745(20300) 24.01 1745(20300) 24.00 100RB (0) 1732.5 (20175) 24.50			1720(20050)	24.16	
1720(20050) 23.73 50RB-Low (0) 1732.5 (20175) 23.95 1745(20300) 24.01 1720(20050) 24.00 100RB (0) 1732.5 (20175) 24.50		50RB-Middle (25)	1732.5 (20175)	24.28	
50RB-Low (0) 1732.5 (20175) 23.95 1745(20300) 24.01 1720(20050) 24.00 100RB (0) 1732.5 (20175) 24.50			1745(20300)	24.18	
1745(20300) 24.01 1720(20050) 24.00 100RB (0) 1732.5 (20175) 24.50			1720(20050)	23.73	
1720(20050)24.00100RB (0)1732.5 (20175)24.50		50RB-Low (0)	1732.5 (20175)	23.95	
100RB (0) 1732.5 (20175) 24.50			1745(20300)	24.01	
			1720(20050)	24.00	
1745(20300)24.11		100RB (0)	1732.5 (20175)	24.50	
			1745(20300)	24.11	







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	LT	E band13		
BANDWIDTH	Number of RBs	Frequency	QPSK	16QAM
		779.5(23205)	25.71	24.59
	1RB-High (24)	782(23230)	25.69	24.11
		784.5(23255)	25.52	25.03
		779.5(23205)	25.80	24.83
	1RB-Middle (12)	782(23230)	25.63	24.15
		784.5(23255)	25.77	24.73
		779.5(23205)	25.65	24.68
	1RB-Low (0)	782(23230)	25.66	24.28
		784.5(23255)	25.63	24.67
		779.5(23205)	24.95	23.70
5MHz	12RB-High (13)	782(23230)	24.70	23.57
		784.5(23255)	24.77	23.49
		779.5(23205)	24.72	23.88
	12RB-Middle (6)	782(23230)	24.72	23.48
		784.5(23255)	24.72	23.53
		779.5(23205)	24.68	23.82
	12RB-Low (0)	782(23230)	24.75	23.77
		784.5(23255)	24.69	23.48
		779.5(23205)	24.70	23.65
	25RB (0)	782(23230)	24.78	23.90
		784.5(23255)	24.67	23.75
	1RB-Low (0)	782(23230)	25.50	
	1RB-Middle (24)	782(23230)	26.01	
	1RB-High (49)	782(23230)	25.62	
10MHz	25RB-Low (25)	782(23230)	24.75	
	25RB-Mid (25)	782(23230)	24.93	
	25RB-High (25)	782(23230)	24.78	
	50RB (0)	782(23230)	24.92	







14.Simultaneous TX SAR Considerations

Note:

For this device, it does not support simultaneous transmission mode.







15.SAR Test Result

15.1 SAR Result

Frequ MHz	uency Ch.	Mode (number of timeslots)	Test Position	Distance (mm)	Conducted Power (dBm)	Max. tune-up Power	Measured SAR(1g) (W/kg)	Reported SAR(1g) (W/kg)	Power Drift (dB)
		20M ODCK 1@M'1	E 4	5	. ,	(dBm)			· · ·
20175	1732.5	20M_QPSK_1@Mid	Front	5	25.33	25.80	0.958	1.07	0.09
20050	1720	20M_QPSK_1@Mid	Front	5	25.03	25.80	0.993	1.19	0.06
20300	1745	20M_QPSK_1@Mid	Front	5	24.96	25.80	0.846	1.03	0.11
20175	1732.5	20M_QPSK_1@Mid	Rear	5	25.33	25.80	0.917	1.02	0.17
20050	1720	20M_QPSK_1@Mid	Rear	5	25.03	25.80	0.837	1.00	0.15
20300	1745	20M_QPSK_1@Mid	Rear	5	24.96	25.80	0.742	0.90	0.10
20175	1732.5	20M_QPSK_1@Mid	Left	5	25.33	25.80	0.304	0.34	-0.40
20175	1732.5	20M_QPSK_1@Mid	Right	5	25.33	25.80	0.305	0.34	0.14
20175	1732.5	20M_QPSK_1@Mid	Тор	5	25.33	25.80	0.714	0.80	0.12
20175	1732.5	20M_QPSK_1@Mid	Bottom	5	25.33	25.80	0.061	0.07	-0.19
20050	1720	20M_QPSK_50@Mid	Front	5	24.16	25.80	0.761	1.11	-0.15
20300	1745	20M_QPSK_50@Mid	Front	5	24.18	25.80	0.774	1.12	0.02
20175	1732.5	20M_QPSK_100@0	Front	5	24.50	25.80	0.818	1.10	-0.14
20050	1720	20M_QPSK_100@0	Front	5	24.00	25.80	0.787	1.19	-0.12
20300	1745	20M_QPSK_100@0	Front	5	24.11	25.80	0.774	1.14	0.09
20175	1732.5	20M_QPSK_50@Mid	Front	5	24.28	25.80	0.898	1.27	0.16
20175	1732.5	20M_QPSK_50@Mid	Front	5	24.28	25.80	0.841	1.19	0.13
20175	1732.5	20M_QPSK_50@Mid	Rear	5	24.28	25.80	0.748	1.06	-0.12
20050	1720	20M_QPSK_50@Mid	Rear	5	24.16	25.80	0.636	0.93	0.11
20300	1745	20M_QPSK_50@Mid	Rear	5	24.18	25.80	0.564	0.82	0.17
20175	1732.5	20M_QPSK_50@Mid	Left	5	24.28	25.80	0.304	0.43	-0.10
20175	1732.5	20M_QPSK_50@Mid	Right	5	24.28	25.80	0.319	0.45	0.10
20175	1732.5	20M_QPSK_50@Mid	Тор	5	24.28	25.80	0.476	0.68	0.03
20175	1732.5	20M_QPSK_50@Mid	Bottom	5	24.28	25.80	0.040	0.06	0.13

Table 15.1-1: SAR Values(LTE Band4-Body)

Note: This max SAR value zoom scan graph is Fig A.1





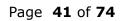


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		1 ubie 1011			Danu15-Dou	5)			
Freq MHz	uency Ch.	Mode (number of timeslots)	Test Position	Distance (mm)	Conducted Power (dBm)	Max. tune-up Power (dBm)	Measured SAR(1g) (W/kg)	Reported SAR(1g) (W/kg)	Power Drift (dB)
782	23230	10M_QPSK_1@Mid	Front	5	26.01	26.50	0.965	1.08	0.01
782	23230	10M_QPSK_1@Mid	Front	5	26.01	26.50	0.944	1.04	0.15
782	23230	10M_QPSK_1@Mid	Rear	5	26.01	26.50	0.503	0.56	0.17
782	23230	10M_QPSK_1@High	Front	5	25.62	26.50	0.626	0.77	-0.19
782	23230	10M_QPSK_1@Low	Front	5	25.50	26.50	0.587	0.74	0.06
782	23230	10M_QPSK_1@Mid	Left	5	26.01	26.50	0.550	0.62	0.11
782	23230	10M_QPSK_1@Mid	Right	5	26.01	26.50	0.430	0.48	0.12
782	23230	10M_QPSK_1@Mid	Тор	5	26.01	26.50	0.372	0.42	0.15
782	23230	10M_QPSK_1@Mid	Bottom	5	26.01	26.50	0.076	0.08	0.19
782	23230	10M_QPSK_25@Mid	Front	5	24.93	26.50	0.544	0.78	0.18
782	23230	10M_QPSK_25@Mid	Rear	5	24.93	26.50	0.503	0.72	-0.17
782	23230	10M_QPSK_25@Mid	Left	5	24.93	26.50	0.657	0.94	0.14
782	23230	10M_QPSK_25@Mid	Right	5	24.93	26.50	0.547	0.79	0.00
782	23230	10M_QPSK_25@Mid	Тор	5	24.93	26.50	0.317	0.46	0.08
782	23230	10M_QPSK_25@Mid	Bottom	5	24.73	26.50	0.080	0.12	0.10
782	23230	10M_QPSK_50@Mid	Front	5	24.92	26.50	0.692	1.00	-0.15

 Table 15.1-2: SAR Values(LTE Band13-Body)

Note: This max SAR value zoom scan graph is Fig A.2





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15.2. SAR Measurement Variability

SAR measurement variability must be assessed for each frequency band, which is determined by the SAR probe calibration point and tissue-equivalent medium used for the device measurements. When both head and body tissue-equivalent media are required for SAR measurements in a frequency band, the variability measurement procedures should be applied to the tissue medium with the highest measured SAR, using the highest measured SAR configuration for that tissue-equivalent medium.

The following procedures are applied to determine if repeated measurements are required.

1) Repeated measurement is not required when the original highest measured SAR is < 0.80 W/kg; steps2) through 4) do not apply.

2) When the original highest measured SAR is ≥ 0.80 W/kg, repeat that measurement once.

3) Perform a second repeated measurement only if the ratio of largest to smallest SAR for the original and first repeated measurements is > 1.20 or when the original or repeated measurement is ≥ 1.45 W/kg (~ 10% from the 1-g SAR limit).

4) Perform a third repeated measurement only if the original, first or second repeated measurement is ≥ 1.5 W/kg and the ratio of largest to smallest SAR for the original, first and second repeated measurements is > 1.20.

Frequ	uency	Mode/band Test Position		Distance	Original measured	First Repeated measured SAR	The Ratio	
MHz	Ch.		1000100	(mm)	SAR (W/kg)	(W/kg)		
1732.5	20175	20M_QPSK_1@Mid	Front	5	0.958	0.935	1.02	
1732.5	20175	20M_QPSK_1@Mid	Rear	5	0.917	0.979	0.94	
1732.5	20175	20M_QPSK_100@0	Front	5	0.818	0.859	0.95	
1732.5	20175	20M_QPSK_50@Mid	Front	5	0.898	0.841	1.07	
782	23230	10M_QPSK_1@Mid	Front	5	0.965	0.944	1.02	

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16. Measurement Uncertainty

	Measurement Uncertainty for Normal SAR Tests (300MHz~3GHz)									
No.	Error Description	Туре	Uncertainty value	Probably Distributio n	Div.	(Ci) 1g	(Ci) 10g	Std. Unc. (1g)	Std. Unc. (10g)	Degree of freedom
Mea	Measurement system									
1	Probe calibration	В	6.0	N	1	1	1	6.0	6.0	x
2	Isotropy	В	4.7	R	$\sqrt{3}$	0.7	0.7	1.9	1.9	x
3	Boundary effect	В	1.0	R	$\sqrt{3}$	1	1	0.6	0.6	x
4	Linearity	В	4.7	R	$\sqrt{3}$	1	1	2.7	2.7	x
5	Detection limit	В	1.0	N	1	1	1	0.6	0.6	x
6	Readout electronics	В	0.3	R	$\sqrt{3}$	1	1	0.3	0.3	x
7	Response time	В	0.8	R	$\sqrt{3}$	1	1	0.5	0.5	x
8	Integration time	В	2.6	R	$\sqrt{3}$	1	1	1.5	1.5	x
9	RF ambient conditions-noise	В	0	R	$\sqrt{3}$	1	1	0	0	x
10	RFambient conditions- reflection	В	0	R	$\sqrt{3}$	1	1	0	0	×
11	Probe positioned mech. restrictions	В	0.4	R	$\sqrt{3}$	1	1	0.2	0.2	x
12	Probe positioning with respect to phantom shell	В	2.9	R	$\sqrt{3}$	1	1	1.7	1.7	×
13	Post-processing	В	1.0	R	$\sqrt{3}$	1	1	0.6	0.6	∞
			Test sa	ample related	ĺ					
14	Test sample positioning	A	3.3	N	1	1	1	3.3	3.3	71
15	Device holder uncertainty	А	3.4	N	1	1	1	3.4	3.4	5
16	Drift of output power	В	5.0	R	$\sqrt{3}$	1	1	2.9	2.9	∞
	i		Phanto	om and set-up)	1				
17	Phantom uncertainty	В	4.0	R	$\sqrt{3}$	1	1	2.3	2.3	x
18	Liquid conductivity (target)	В	5.0	R	$\sqrt{3}$	0.64	0.43	1.8	1.2	x
19	Liquid conductivity (meas.)	A	2.06	N	1	0.64	0.43	1.32	0.89	43
20	Liquid permittivity (target)	В	5.0	R	$\sqrt{3}$	0.6	0.49	1.7	1.4	∞
21	Liquid permittivity (meas.)	A	1.6	N	1	0.6	0.49	1.0	0.8	521
	Combined standard uncertainty	u' _c =	$\sqrt{\sum_{i=1}^{21} c_i^2 u_i^2}$					9.55	9.43	257
	nded uncertainty fidence interval of	1	$u_e = 2u_c$					19.1	18.9	

Massurament Uncertainty for Normal SAD Tests (300MHz. 3CHz)







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Measurement Uncertainty for Fast SAR Tests (300MHz~3GHz)										
No.	Error Description	Тур	Uncertainty	Probably	Div	(Ci)	(Ci)	Std.	Std.	Degree
		e	value	Distribution	•	1g	10g	Unc.	Unc.	of
								(1g)	(10g)	freedom
	surement system						-			
1	Probe calibration	B	6.0	N	1	1	1	6.0	6.0	00
2	Isotropy	В	4.7	R	$\sqrt{3}$	0.7	0.7	1.9	1.9	00
3	Boundary effect	В	1.0	R	$\sqrt{3}$	1	1	0.6	0.6	œ
4	Linearity	В	4.7	R	$\sqrt{3}$	1	1	2.7	2.7	00
5	Detection limit	В	1.0	R	$\sqrt{3}$	1	1	0.6	0.6	00
6	Readout electronics	В	0.3	R	$\sqrt{3}$	1	1	0.3	0.3	œ
7	Response time	В	0.8	R	$\sqrt{3}$	1	1	0.5	0.5	œ
8	Integration time	В	2.6	R	$\sqrt{3}$	1	1	1.5	1.5	00
9	RF ambient conditions-noise	В	0	R	$\sqrt{3}$	1	1	0	0	x
10	RFambient conditions-reflection	В	0	R	$\sqrt{3}$	1	1	0	0	∞
11	Probe positioned mech. Restrictions	В	0.4	R	$\sqrt{3}$	1	1	0.2	0.2	œ
12	Probe positioning with respect to phantom shell	В	2.9	R	$\sqrt{3}$	1	1	1.7	1.7	x
13	Post-processing	В	1.0	R	$\sqrt{3}$	1	1	0.6	0.6	œ
14	Fast SAR z- Approximation	В	7.0	R	$\sqrt{3}$	1	1	4.0	4.0	œ
		•	Test	sample related	1					
15	Test sample positioning	A	3.3	N	1	1	1	3.3	3.3	71
16	Device holder uncertainty	А	3.4	N	1	1	1	3.4	3.4	5
17	Drift of output power	В	5.0	R	$\sqrt{3}$	1	1	2.9	2.9	x
			Phan	tom and set-u	р					
18	Phantom uncertainty	В	4.0	R	$\sqrt{3}$	1	1	2.3	2.3	œ
19	Liquid conductivity (target)	В	5.0	R	$\sqrt{3}$	0.64	0.43	1.8	1.2	x
20	Liquid conductivity (meas.)	А	2.06	Ν	1	0.64	0.43	1.32	0.89	43
21	Liquid permittivity (target)	В	5.0	R	$\sqrt{3}$	0.6	0.49	1.7	1.4	x
22	Liquid permittivity (meas.)	А	1.6	Ν	1	0.6	0.49	1.0	0.8	521
	bined standard rtainty	<i>u</i> _c =	$\sqrt{\sum_{i=1}^{22} c_i^2 u_i^2}$					10.4	10.3	257
	nded uncertainty fidence interval of	1	$u_e = 2u_c$					20.8	20.6	

Measurement Uncertainty for Fast SAR Tests (300MHz~3GHz)

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17. Test Equipments Utilized

17.1 Main Instruments

No.	Name	Туре	Serial Number	Software version	Hardware version	Calibr ation Date	Valid Perio d
01	Probe	EX3DV4	7633			2023- 07-25	2024- 07-24
02	DAE	DAE4	1329			2023- 04-28	2024- 04-27
03	Power Meter	N1914A	MY5000 1660			2023- 05-29	2024- 05-28
04	Radio Commu nication Analyzer	CMW500	109616			2023- 05-29	2024- 05-28
05	Signal Generator	N5181A	MY5014 3363			2023- 05-29	2024- 05-28
06	Power Sensor	E8481H	MY5102 0011			2023- 05-29	2024- 05-28
07	Power Amplifier	ZHL	QA12020 03			2023- 05-29	2024- 05-28
08	Network Analyzer	E5071C	MY4621 2462	A.10.0x	8.0	2023- 05-29	2024- 05-28
09	D835V2	Dipole	4d169			2023- 12-14	2024- 12-13
10	D1750V2	Dipole	1063			2023- 12-14	2027- 12-13

Table 17-1: List of Main Instruments

17.2 Test software

No.	Name	Name version SN		Manufacture	
1	DASY5 PRO	5210.4.1527		speng	
2	85070	E05.01.12		Agilent	

END OF REPORT BODY

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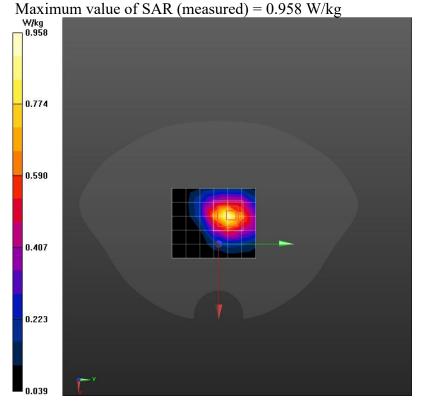




ANNEX A. GRAPH RESULTS

LTE Band4 Body Front (5mm)

Date/Time: 2024/3/8 Electronics: DAE4 Sn1329 Medium: Head 1750MHz Medium parameters used: f = 1745 MHz; $\sigma = 1.332$ S/m; $\varepsilon r = 41.098$; $\rho = 1000$ kg/m3 Ambient Temperature:22.5°C Liquid Temperature:22.1°C Communication System: LTE Band 4 (0); Frequency: 1732.5 MHz; Duty Cycle: 1:1 Probe: EX3DV4 - SN3844ConvF(8.5, 8.5, 8.5) **Area Scan (5x4x1):** Measurement grid: dx=15mm, dy=15mm Maximum value of SAR (measured) = 0.926 W/kg **Zoom Scan (5x5x7)/Cube 0:** Measurement grid: dx=8mm, dy=8mm, dz=5mm Reference Value = 27.86 V/m; Power Drift = 0.16 dB Peak SAR (extrapolated) = 1.31 W/kg **SAR(1 g) = 0.898 W/kg; SAR(10 g) = 0.568 W/kg**

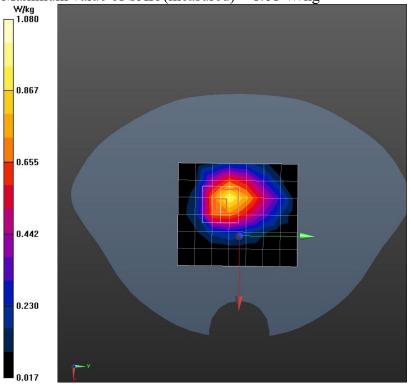






LTE Band13 Body Front (5mm)

Date/Time: 2024/3/11 Electronics: DAE4 Sn1329 Medium: Head 835MHz Medium parameters used: f = 782 MHz; $\sigma = 0.904$ S/m; $\epsilon r = 41.421$; $\rho = 1000$ kg/m3 Ambient Temperature:22.5°C Liquid Temperature:22.1°C Communication System: LTE Band 13 (0); Frequency: 782 MHz; Duty Cycle: 1:1 Probe: EX3DV4 - SN3844ConvF(9.96, 9.96, 9.96) Area Scan (6x8x1): Measurement grid: dx=15mm, dy=15mm Maximum value of SAR (measured) = 0.956 W/kgZoom Scan (5x5x7)/Cube 0: Measurement grid: dx=8mm, dy=8mm, dz=5mm Reference Value = 24.61 V/m; Power Drift = 0.01 dBPeak SAR (extrapolated) = 1.72 W/kgSAR(1 g) = 0.965 W/kg; SAR(10 g) = 0.561 W/kgMaximum value of SAR (measured) = 1.08 W/kg





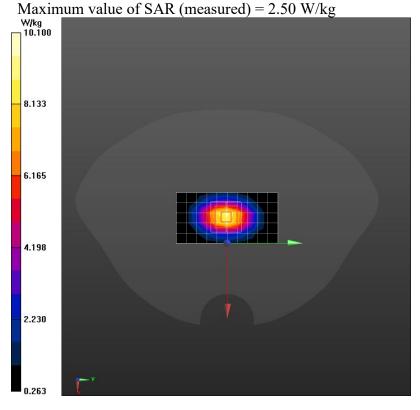




ANNEX B. SYSTEM VALIDATION RESULTS

System Valiation 835 MHz

Date/Time: 2024/3/11 Electronics: DAE4 Sn1329 Medium: Head 835MHz Medium parameters used: f = 835 MHz; $\sigma = 0.915$ S/m; ε r = 43.156; $\rho = 1000$ kg/m3 Ambient Temperature:22.5°C Liquid Temperature:22.1°C Communication System: CW (0); Frequency: 835 MHz; Duty Cycle: 1:1 Probe: EX3DV4 - SN3844ConvF(9.5, 9.5, 9.5) **Area Scan (5x18x1):** Measurement grid: dx=10mm, dy=10mm Maximum value of SAR (measured) = 2.52 W/kg **Zoom Scan (7x7x7)/Cube 0:** Measurement grid: dx=5mm, dy=5mm, dz=5mm Reference Value = 52.77 V/m; Power Drift = -0.02 dB Peak SAR (extrapolated) = 3.46 W/kg **SAR(1 g) = 2.32 W/kg; SAR(10 g) = 1.52 W/kg**



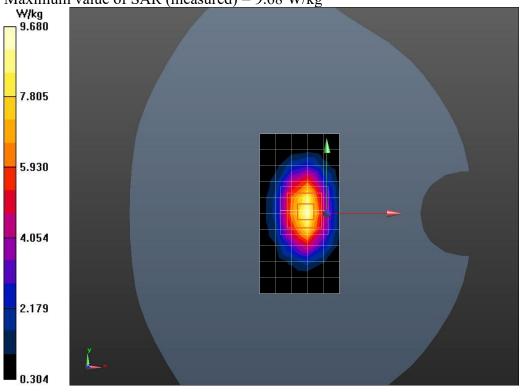
Chongqing Academy of Information and Communication Technology Address: No. 8,Yuma Road, Chayuan New City, Nan'an District, Chongqing, P. R. China,401336 Tel: 0086-23-88069965 FAX:0086-23-88069777

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System Valiation 1750MHz

Date/Time: 2024/3/11 Electronics: DAE4 Sn1329 Medium: Head 1750MHz Medium parameters used: f = 1750 MHz; $\sigma = 1.361 \text{ S/m}$; $\epsilon r = 41.103$; $\rho = 1000 \text{ kg/m3}$ Ambient Temperature:22.5°C Liquid Temperature:22.1°C Communication System: CW (0); Frequency: 1750 MHz; Duty Cycle: 1:1 Probe: EX3DV4 - SN3844ConvF(8.5, 8.5, 8.5) Area Scan (6x11x1): Measurement grid: dx=10mm, dy=10mm Maximum value of SAR (measured) = 9.51 W/kgZoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm Reference Value = 81.33 V/m; Power Drift =0.02 dB Peak SAR (extrapolated) = 15.0 W/kgSAR(1 g) = 8.63 W/kg; SAR(10 g) = 4.73 W/kg Maximum value of SAR (measured) = 9.68 W/kg





ANNEX C. CALIBRATION REPORT

E-mail: emf@caict.ac.cn	http://www.caict.ac		No: J23Z60331
		,	
CALIBITATION			
Object	DAE	4 - SN: 1329	
Calibration Procedure(s)	11-2	11-002-01 ration Procedure for the Data Acquisi x)	ition Electronics
Calibration date:	July	25, 2023	
measurements(SI). The pages and are part of the	measurements ar e certificate.	e traceability to national standards, whi Id the uncertainties with confidence proba- the closed laboratory facility: enviror	ability are given on the following
measurements(SI). The pages and are part of the All calibrations have be	measurements ar a certificate. aen conducted ir sed (M&TE critica	nd the uncertainties with confidence proba	ability are given on the following
measurements(SI). The pages and are part of the pages and are part of the All calibrations have be humidity<70%.	measurements ar a certificate. aen conducted ir sed (M&TE critica	nd the uncertainties with confidence proba n the closed laboratory facility: enviror I for calibration)	ability are given on the following
measurements(SI). The pages and are part of the pages and are part of the All calibrations have be humidity<70%. Calibration Equipment us Primary Standards	measurements ar e certificate. een conducted ir sed (M&TE critica	nd the uncertainties with confidence proba n the closed laboratory facility: enviror I for calibration) Cal Date(Calibrated by, Certificate No.)	ability are given on the following ment temperature(22±3)°C and Scheduled Calibration
measurements(SI). The loages and are part of the bages and are part of the humidity<70%. Calibration Equipment us Primary Standards Process Calibrator 753	measurements ar e certificate. een conducted ir sed (M&TE critica ID # (1971018	nd the uncertainties with confidence proba n the closed laboratory facility: environ l for calibration) Cal Date(Calibrated by, Certificate No.) 12-Jun-23 (CTTL, No.J23X05436) Function	ability are given on the following ment temperature(22±3)°C and Scheduled Calibration Jun-24
measurements(SI). The pages and are part of the pages and are part of the All calibrations have be humidity<70%. Calibration Equipment us Primary Standards	measurements ar e certificate. een conducted ir sed (M&TE critica ID # (1971018 Name	nd the uncertainties with confidence proba n the closed laboratory facility: environ l for calibration) Cal Date(Calibrated by, Certificate No.) 12-Jun-23 (CTTL, No.J23X05436) Function	ability are given on the following ment temperature(22±3)°C and Scheduled Calibration Jun-24

Certificate No: J23Z60331

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Report No.: 24B02W000008-005





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Glossary: DAE

Connector angle

data acquisition electronics information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters:

- DC Voltage Measurement: Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- Connector angle: The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The report provide only calibration results for DAE, it does not contain other . performance test results.

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CAIC Report No.: 24B02W000008-005





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-1

DC Voltage Measurement

A/D - Converter Res	solution nomin	Idl			
High Range:	1LSB =	6.1µV,	full	range =	-100+300 mV
Low Range:	1LSB =	61nV,		range =	-1+3mV
DASY measuremen	t parameters:	Auto Zero	Time: 3	sec; Mea	asuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	404.385 ± 0.15% (k=2)	404.516 ± 0.15% (k=2)	404.110 \pm 0.15% (k=2)
Low Range	3.99857 ± 0.7% (k=2)	3.99517 ± 0.7% (k=2)	4.00130 ± 0.7% (k=2)

Connector Angle

Connector Angle to be used in DASY system	103.5°±1°

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CAICT Report No.: 24B02W000008-005

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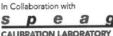
Add: No.52 Hua Yuan Bei Ro	C a g	ing 100191. China	CALIBRATION
Tel: +86-10-62304633-2117		and the prove	CNAS L0570
E-mail: emf@caict.ac.cn	(Chongqing)	Certificat	te No: J23Z60330
Oliciti			
CALIBRATION CI	ERTIFICATE		
Object	EX3DV4 -	SN : 3844	
Calibration Procedure(s)	FF-Z11-00		
	Calibration	Procedures for Dosimetric E-field	Probes
Calibration date:	August 07	2023	
Gallbration date.	August of	, 2023	
This calibration Certificate docur	ments the traceability to	national standards, which realize the pl	nysical units of measurements(SI). The
measurements and the uncertain	nties with confidence p	obability are given on the following page	es and are part of the certificate.
All calibrations have been condu	icted in the closed labo	ratory facility: environment temperature(22±3)℃ and humidity<70%.
Calibration Equipment used (M8			
Primary Standards		a Dato(calibrated 2), continents,	Scheduled Calibration
Power Meter NRP2	101919	12-Jun-23(CTTL, No.J23X05435)	Jun-24 Jun-24
Power sensor NRP-Z91	101547	12-Jun-23(CTTL, No.J23X05435)	
Power sensor NRP-Z91	101548	12-Jun-23(CTTL, No.J23X05435)	Jun-24 Jan-25
Reference 10dBAttenuator	18N50W-10dB	19-Jan-23(CTTL, No.J23X00212)	
Reference 20dBAttenuator	18N50W-20dB	19-Jan-23(CTTL, No.J23X00211)	Jan-25
Reference Probe EX3DV4	SN 3846	31-May-23(SPEAG, No.EX-3846_Ma	
DAE4	SN 1555	25-Aug-22(SPEAG, No.DAE4-1555_	
DAE4	SN 549	24-Jan-23(SPEAG, No.DAE4-549_J	
Secondary Standards	ID #	Cal Date(Calibrated by, Certificate N	o.) Scheduled Calibration
SignalGenerator MG3700A	6201052605	12-Jun-23(CTTL, No.J23X05434)	Jun-24
Network Analyzer E5071C	MY46110673	10-Jan-23(CTTL, No.J23X00104)	Jan-24
Reference 10dBAttenuator	BT0520	11-May-23(CTTL, No.J23X04061)	May-25
Reference 20dBAttenuator	BT0267	11-May-23(CTTL, No.J23X04062)	May-25
OCP DAK-3.5	SN 1040	18-Jan-23(SPEAG, No.OCP-DAK3.5	5-1040_Jan23) Jan-24
N	lame	Function	Signature
Calibrated by:	Yu Zongying	SAR Test Engineer	Assort
Reviewed by:	Lin Hao	SAR Test Engineer	117-75
Approved by:	Qi Dianyuan	SAR Project Leader	era
		Is	ssued: August 13, 2023
This calibration certificate shall r	not be reproduced exce	pt in full without written approval of the l	•

Certificate No: J23Z60330

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Glossary:

tissue simulating liquid TSL NORMx,y,z sensitivity in free space sensitivity in TSL / NORMx,y,z ConvF DCP diode compression point crest factor (1/duty_cycle) of the RF signal CF modulation dependent linearization parameters A.B.C.D Φ rotation around probe axis Polarization Φ θ rotation around an axis that is in the plane normal to probe axis (at measurement center), i Polarization θ

θ=0 is normal to probe axis Connector Angle information used in DASY system to align probe sensor X to the robot coordinate system

Calibration is Performed According to the Following Standards:
 a) IEEE Std 1528-2013, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices:

Measurement Techniques", June 2013 b) IEC 62209-1, "Measurement procedure for the assessment of Specific Absorption Rate (SAR) from hand-held and body-mounted devices used next to the ear (frequency range of 300 MHz to 6 GHz)", July 2016

c) IEC 62209-2, "Procedure to determine the Specific Absorption Rate (SAR) for wireless communication devices used in close proximity to the human body (frequency range of 30 MHz to 6 GHz)", March 2010

d) KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz"

Methods Applied and Interpretation of Parameters:

- NORMx, y,z: Assessed for E-field polarization θ=0 (f≤900MHz in TEM-cell; f>1800MHz: waveguide). NORMx, y,z are only intermediate values, i.e., the uncertainties of NORMx, y,z does not effect the E²-field uncertainty inside TSL (see below ConvF).
- NORM(f)x,y,z = NORMx,y,z* frequency_response (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- *DCPx,y,z:* DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency nor media.
- PAR: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics.
- Ax, y, z; Bx, y, z; Cx, y, z; VRx, y, z: A, B, C are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- ConvF and Boundary Effect Parameters: Assessed in flat phantom using E-field (or Temperature Transfer Standard for f≤800MHz) and inside waveguide using analytical field distributions based on power measurements for f >800MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty valued are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORMx,y,z* ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from±50MHz to±100MHz.
- Spherical isotropy (3D deviation from isotropy): in a field of low gradients realized using a flat
 phantom exposed by a patch antenna.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the
 probe tip (on probe axis). No tolerance required.
- Connector Angle: The angle is assessed using the information gained by determining the NORMx (no uncertainty required).

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DASY/EASY – Parameters of Probe: EX3DV4 – SN:3844

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (<i>k</i> =2)
Norm(µV/(V/m) ²) ^A	0.49	0.41	0.19	±10.0%
DCP(mV) ^B	103.9	103.3	97.2	

Modulation Calibration Parameters

UID	Communication System Name		A dB	B dBõV	С	D dB	VR mV	Unc ^E (<i>k</i> =2)
0	0 CW	X	0.0	0.0	1.0	0.00	182.0	±2.2%
		Y	0.0	0.0	1.0		158.4	
		z	0.0	0.0	1.0		95.9	

The reported uncertainty of measurement is stated as the standard uncertainty of Measurement multiplied by the coverage factor k=2, which for a normal distribution Corresponds to a coverage probability of approximately 95%.

^A The uncertainties of Norm X, Y, Z do not affect the E²-field uncertainty inside TSL (see Page 4).

^B Numerical linearization parameter: uncertainty not required.

^E Uncertainly is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

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DASY/EASY – Parameters of Probe: EX3DV4 – SN:3844

Calibration Parameter Determined in Head Tissue Simulating Media

f [MHz] ^C	Relative Permittivity ^F	Conductivity (S/m) ^F	ConvF X	ConvF Y	ConvF Z	Alpha ^G	Depth ^G (mm)	Unct. (<i>k</i> =2)
750	41.9	0.89	9.97	9.97	9.97	0.24	1.05	±12.7%
900	41.5	0.97	9.58	9.58	9.58	0.30	1.02	±12.7%
1750	40.1	1.37	8.49	8.49	8.49	0.31	0.91	±12.7%
1900	40.0	1.40	8.12	8.12	8.12	0.33	0.93	±12.7%
2100	39.8	1.49	8.11	8.11	8.11	0.22	1.13	±12.7%
2300	39.5	1.67	7.97	7.97	7.97	0.48	0.75	±12.7%
2450	39.2	1.80	7.74	7.74	7.74	0.56	0.71	±12.7%
2600	39.0	1.96	7.56	7.56	7.56	0.62	0.67	±12.7%

^c Frequency validity above 300 MHz of ±100MHz only applies for DASY v4.4 and higher (Page 2), else it is restricted to ±50MHz. The uncertainty is the RSS of ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band. Frequency validity below 300 MHz is ± 10, 25, 40, 50 and 70 MHz for ConvF assessments at 30, 64, 128, 150 and 220 MHz respectively. Above 5 GHz frequency validity can be extended to ± 110 MHz.

^F At frequency up to 6 GHz, the validity of tissue parameters (ϵ and σ) can be relaxed to ±10% if liquid compensation formula is applied to measured SAR values. The uncertainty is the RSS of the ConvF uncertainty for indicated target tissue parameters.

^G Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less than \pm 1% for frequencies below 3 GHz and below \pm 2% for the frequencies between 3-6 GHz at any distance larger than half the probe tip diameter from the boundary.

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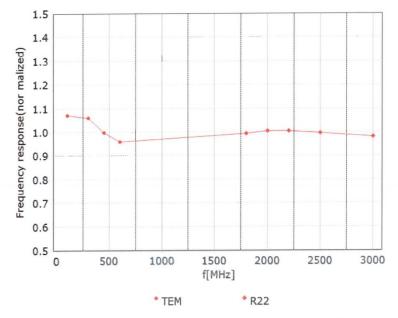








Frequency Response of E-Field (TEM-Cell: ifi110 EXX, Waveguide: R22)



Uncertainty of Frequency Response of E-field: ±7.4% (k=2)

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CAICT Report No.: 24B02W000008-005



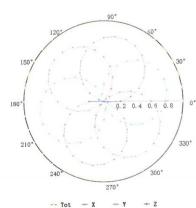


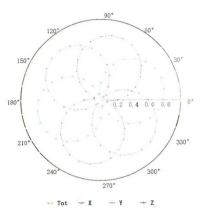
Add: No.52 HuaYuanBei Road, Haidian District, Beijing, 100191, China Tel: +86-10-62304633-2117 E-mail: emf@caiet.ac.en http://www.caiet.ac.en

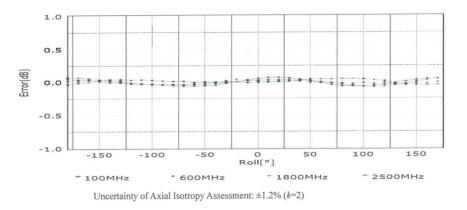
Receiving Pattern (Φ), θ=0°

f=600 MHz, TEM

f=1800 MHz, R22







Certificate No:J23Z60330

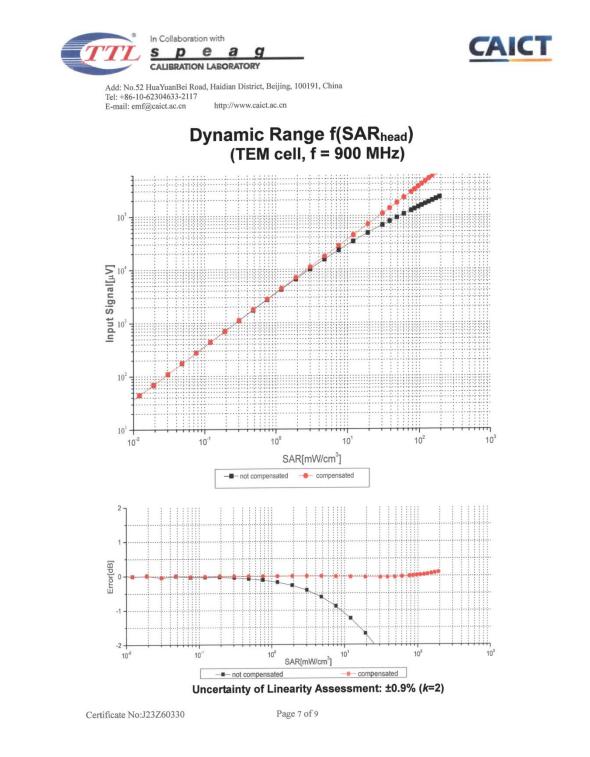
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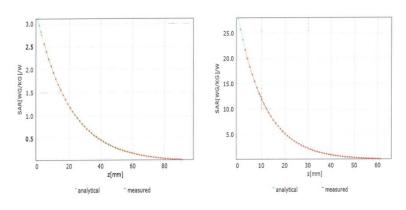




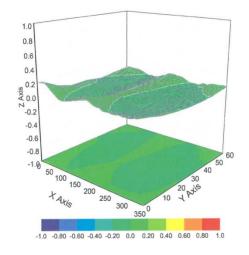
Conversion Factor Assessment

f=750 MHz,WGLS R9(H_convF)

f=1750 MHz,WGLS R22(H_convF)



Deviation from Isotropy in Liquid



Uncertainty of Spherical Isotropy Assessment: ±3.2% (k=2)

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DASY/EASY – Parameters of Probe: EX3DV4 – SN:3844

Other Probe Parameters

Sensor Arrangement	Triangular
Connector Angle (°)	29.5
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disable
Probe Overall Length	337mm
Probe Body Diameter	10mm
Tip Length	9mm
Tip Diameter	2.5mm
Probe Tip to Sensor X Calibration Point	1mm
Probe Tip to Sensor Y Calibration Point	1mm
Probe Tip to Sensor Z Calibration Point	1mm
Recommended Measurement Distance from Surface	1.4mm

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E-mail: emf@caict.ac.cn	http://www.caict		3J02Z80197
Client CATR((Chongqing)	Certificate No: 23	5502200197
CALIBRATION CE	RTIFICAT	E	
Dbject	D835V2	2 - SN: 4d169	
Calibration Procedure(s)	FF-Z11-	-003-01	
	Calibrat	tion Procedures for dipole validation kits	
Calibration date:	Decem	ber 14, 2023	
neasurements (SI). The mean bages and are part of the cer		the uncertainties with confidence probability	are given on the following
	conducted in t	he closed laboratory facility: environment	temperature (22±3)°C and
numidity<70%.	(M&TE critical fo	or calibration)	
umidity<70%. Calibration Equipment used (Primary Standards	(M&TE critical fo	or calibration) Cal Date (Calibrated by, Certificate No.)	Scheduled Calibration
umidity<70%. Calibration Equipment used Primary Standards Power Meter NRP2	(M&TE critical fo ID # 106276	or calibration) Cal Date (Calibrated by, Certificate No.) 15-May-23 (CTTL, No.J23X04183)	Scheduled Calibration May-24
umidity<70%. Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP6A	(M&TE critical fo ID # 106276 101369	Cal Date (Calibrated by, Certificate No.) 15-May-23 (CTTL, No.J23X04183) 15-May-23 (CTTL, No.J23X04183)	Scheduled Calibration May-24 May-24
umidity<70%. Calibration Equipment used	(M&TE critical fo ID # 106276	or calibration) Cal Date (Calibrated by, Certificate No.) 15-May-23 (CTTL, No.J23X04183)	Scheduled Calibration May-24
Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP6A Reference Probe EX3DV4 DAE4	(M&TE critical fo ID # 106276 101369 SN 3617	Cal Date (Calibrated by, Certificate No.) 15-May-23 (CTTL, No.J23X04183) 15-May-23 (CTTL, No.J23X04183) 31-Mar-23(CTTL-SPEAG,No.Z23-60161)	Scheduled Calibration May-24 May-24 Mar-24
Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP6A Reference Probe EX3DV4 DAE4 Secondary Standards	(M&TE critical fo ID # 106276 101369 SN 3617 SN 1556	Cal Date (Calibrated by, Certificate No.) 15-May-23 (CTTL, No.J23X04183) 15-May-23 (CTTL, No.J23X04183) 31-Mar-23 (CTTL-SPEAG,No.Z23-60161) 11-Jan-23 (CTTL-SPEAG,No.Z23-60034) Cal Date (Calibrated by, Certificate No.)	Scheduled Calibration May-24 May-24 Mar-24 Jan-24
Calibration Equipment used of Primary Standards Power Meter NRP2 Power sensor NRP6A Reference Probe EX3DV4 DAE4	(M&TE critical fo ID # 106276 101369 SN 3617 SN 1556 ID #	Cal Date (Calibrated by, Certificate No.) 15-May-23 (CTTL, No.J23X04183) 15-May-23 (CTTL, No.J23X04183) 31-Mar-23 (CTTL-SPEAG,No.Z23-60161) 11-Jan-23 (CTTL-SPEAG,No.Z23-60034) Cal Date (Calibrated by, Certificate No.)	Scheduled Calibration May-24 May-24 Mar-24 Jan-24 Scheduled Calibration
aumidity<70%. Calibration Equipment used (Primary Standards Power Meter NRP2 Power sensor NRP6A Reference Probe EX3DV4 DAE4 Secondary Standards Signal Generator E4438C	(M&TE critical fo ID # 106276 101369 SN 3617 SN 1556 ID # MY49071430	Cal Date (Calibrated by, Certificate No.) 15-May-23 (CTTL, No.J23X04183) 15-May-23 (CTTL, No.J23X04183) 31-Mar-23(CTTL-SPEAG,No.Z23-60161) 11-Jan-23(CTTL-SPEAG,No.Z23-60034) Cal Date (Calibrated by, Certificate No.) 05-Jan-23 (CTTL, No. J23X00107)	Scheduled Calibration May-24 May-24 Mar-24 Jan-24 Scheduled Calibration Jan-24
aumidity<70%. Calibration Equipment used (Primary Standards Power Meter NRP2 Power sensor NRP6A Reference Probe EX3DV4 DAE4 Secondary Standards Signal Generator E4438C NetworkAnalyzer E5071C	(M&TE critical fo ID # 106276 101369 SN 3617 SN 1556 ID # MY49071430 MY46110673	Cal Date (Calibrated by, Certificate No.) 15-May-23 (CTTL, No.J23X04183) 15-May-23 (CTTL, No.J23X04183) 31-Mar-23(CTTL-SPEAG,No.Z23-60161) 11-Jan-23(CTTL-SPEAG,No.Z23-60034) Cal Date (Calibrated by, Certificate No.) 05-Jan-23 (CTTL, No. J23X00107) 10-Jan-23 (CTTL, No. J23X00104)	Scheduled Calibration May-24 May-24 Mar-24 Jan-24 Scheduled Calibration Jan-24 Jan-24
aumidity<70%. Calibration Equipment used (Primary Standards Power Meter NRP2 Power sensor NRP6A Reference Probe EX3DV4 DAE4 Secondary Standards Signal Generator E4438C NetworkAnalyzer E5071C Calibrated by:	(M&TE critical fo ID # 106276 101369 SN 3617 SN 1556 ID # MY49071430 MY46110673 Name	Cal Date (Calibrated by, Certificate No.) 15-May-23 (CTTL, No.J23X04183) 15-May-23 (CTTL, No.J23X04183) 31-Mar-23 (CTTL-SPEAG,No.Z23-60161) 11-Jan-23 (CTTL-SPEAG,No.Z23-60034) Cal Date (Calibrated by, Certificate No.) 05-Jan-23 (CTTL, No. J23X00107) 10-Jan-23 (CTTL, No. J23X00104) Function	Scheduled Calibration May-24 May-24 Mar-24 Jan-24 Scheduled Calibration Jan-24 Jan-24
Aumidity<70%. Calibration Equipment used (Primary Standards Power Meter NRP2 Power sensor NRP6A Reference Probe EX3DV4 DAE4 Secondary Standards Signal Generator E4438C	(M&TE critical fo ID # 106276 101369 SN 3617 SN 1556 ID # MY49071430 MY46110673 Name Zhao Jing	Cal Date (Calibrated by, Certificate No.) 15-May-23 (CTTL, No.J23X04183) 15-May-23 (CTTL, No.J23X04183) 31-Mar-23(CTTL-SPEAG,No.Z23-60161) 11-Jan-23(CTTL-SPEAG,No.Z23-60034) Cal Date (Calibrated by, Certificate No.) 05-Jan-23 (CTTL, No. J23X00107) 10-Jan-23 (CTTL, No. J23X00104) Function SAR Test Engineer	Scheduled Calibration May-24 May-24 Mar-24 Jan-24 Scheduled Calibration Jan-24 Jan-24

Certificate No: 23J02Z80197

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Glossary: TSL

Con N/A

tingue aimulating liquid
tissue simulating liquid
sensitivity in TSL / NORMx,y,z
not applicable or not measured

Calibration is Performed According to the Following Standards:

- a) IEC/IEEE 62209-1528, "Measurement Procedure for The Assessment of Specific Absorption Rate of Human Exposure to Radio Frequency Fields from Hand-held and Body-mounted Wireless Communication Devices- Part 1528: Human Models, Instrumentation and Procedures (Frequency range of 4 MHz to 10 GHz)", October 2020
- b) KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz"

Additional Documentation:

c) DASY4/5 System Handbook

Methods Applied and Interpretation of Parameters:

- Measurement Conditions: Further details are available from the Validation Report at the end
 of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL: The dipole is mounted with the spacer to position its feed
 point exactly below the center marking of the flat phantom section, with the arms oriented
 parallel to the body axis.
- Feed Point Impedance and Return Loss: These parameters are measured with the dipole
 positioned under the liquid filled phantom. The impedance stated is transformed from the
 measurement at the SMA connector to the feed point. The Return Loss ensures low
 reflected power. No uncertainty required.
- Electrical Delay: One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- SAR measured: SAR measured at the stated antenna input power.
- SAR normalized: SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters: The measured TSL parameters are used to calculate the nominal SAR result.

The reported uncertainty of measurement is stated as the standard uncertainty of Measurement multiplied by the coverage factor k=2, which for a normal distribution Corresponds to a coverage probability of approximately 95%.

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Measurement Conditions

DASY Version	DASY52	V52.10.4
Extrapolation	Advanced Extrapolation	
Phantom	Triple Flat Phantom 5.1C	
Distance Dipole Center - TSL	15 mm	with Spacer
oom Scan Resolution	dx, dy, dz = 5 mm	
Frequency	835 MHz ± 1 MHz	

Head TSL parameters The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	41.5	0.90 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	41.0 ± 6 %	0.91 mho/m ± 6 %
Head TSL temperature change during test	<1.0 °C		

SAR result with Head TSL

SAR averaged over 1 cm^3 (1 g) of Head TSL	Condition	
SAR measured	250 mW input power	2.41 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	9.53 W/kg ± 18.8 % (k=2)
SAR averaged over 10 cm^3 (10 g) of Head TSL	Condition	
SAR measured	250 mW input power	1.56 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	6.18 W/kg ± 18.7 % (<i>k</i> =2)

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Appendix (Additional assessments outside the scope of CNAS L0570)

Antenna Parameters with Head TSL

Impedance, transformed to feed point	53.6Ω+ 4.47jΩ	
Return Loss	- 25.1dB	

General Antenna Parameters and Design

Electrical Delay (one direction)	1.304 ns	
----------------------------------	----------	--

After long term use with 100W radiated power, only a slight warming of the dipole near the feed-point can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals. On some of the dipoles, small end caps are added to the dipole arms in order to improve matching when loaded according to the position as explained in the "Measurement Conditions" paragraph. The SAR data are not affected by this change. The overall dipole length is still according to the Standard. No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feed-point may be damaged.

Additional EUT Data

Manufactured by	SPEAG

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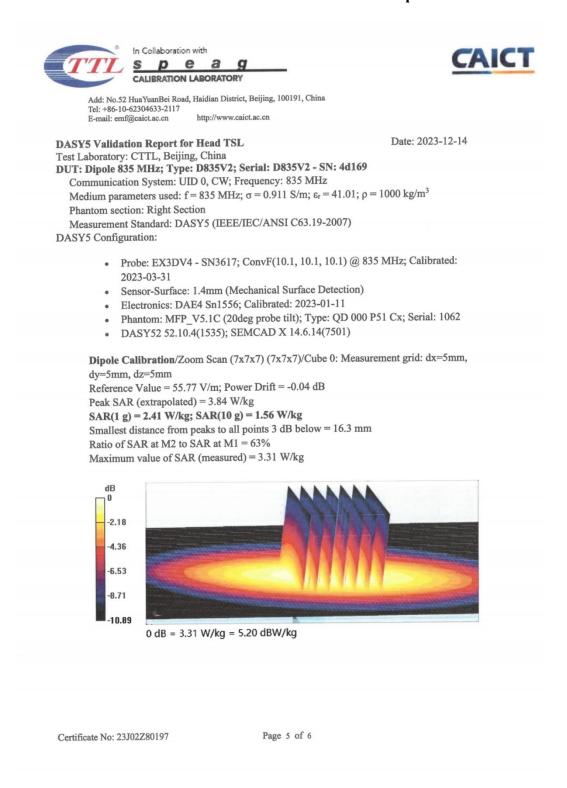
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CAIC Report No.: 24B02W000008-005

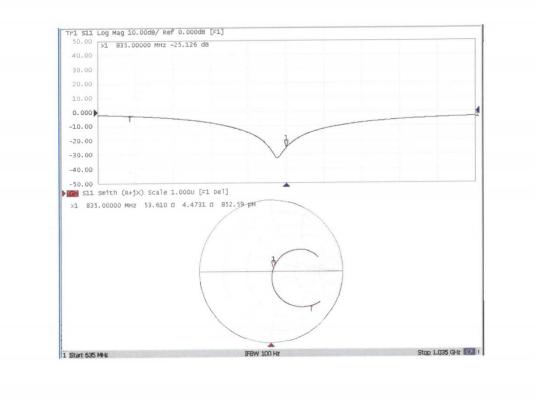




CAICT Report No.: 24B02W000008-005



Impedance Measurement Plot for Head TSL







Report No.: 24B02W000008-005

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	ion with e a g IN LABORATORY		中国认可 国际互认 校准 CALIBRATION
Add: No.52 HuaYuanBei Rog Tel: +86-10-62304633-2117 E-mail: emf@caict.ac.cn Client CATR	ad, Haidian District, 1 http://www.caict (Chongqing)		23J02Z80199
CALIBRATION CE		E	
			2
Object	D1750\	/2 - SN: 1063	
Calibration Procedure(s)	FF-Z11 Calibrat	003-01 ion Procedures for dipole validation kits	
Calibration date:	Decem	per 14, 2023	
This calibration Certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.			
All calibrations have been humidity<70%.	conducted in th	ne closed laboratory facility: environme	nt temperature (22±3)°C and
Calibration Equipment used	(M&TE critical for	or calibration)	
Primary Standards	ID #	Cal Date (Calibrated by, Certificate No.) Scheduled Calibration
Power Meter NRP2	106276	15-May-23 (CTTL, No.J23X04183)	May-24
Power sensor NRP6A	101369	15-May-23 (CTTL, No.J23X04183)	May-24
Reference Probe EX3DV4	SN 3617	31-Mar-23(CTTL-SPEAG,No.Z23-6016	
DAE4	SN 1556	11-Jan-23(CTTL-SPEAG,No.Z23-60034) Jan-24
Secondary Standards	ID #	Cal Date (Calibrated by, Certificate No.)	Scheduled Calibration
Signal Generator E4438C	MY49071430	05-Jan-23 (CTTL, No. J23X00107)	Jan-24
Network Analyzer E5071C	MY46110673	10-Jan-23 (CTTL, No. J23X00104)	Jan-24
	Nome	Function	Signature
O-liberated by:	Name		
Calibrated by:	Zhao Jing	SAR Test Engineer	教 創
Reviewed by:	Lin Hao	SAR Test Engineer	the the
Approved by:	Qi Dianyuan	SAR Project Leader	Ath
			ecember 19, 2023
This calibration certificate sh	nall not be reproc	luced except in full without written approv	al of the laboratory.

Certificate No: 23J02Z80199

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 Glossary:

 TSL
 tissue simulating liquid

 ConvF
 sensitivity in TSL / NORMx,y,z

 N/A
 not applicable or not measured

Calibration is Performed According to the Following Standards:

a) IEC/IEEE 62209-1528, "Measurement Procedure for The Assessment of Specific Absorption Rate of Human Exposure to Radio Frequency Fields from Hand-held and Body-mounted Wireless Communication Devices- Part 1528: Human Models, Instrumentation and Procedures (Frequency range of 4 MHz to 10 GHz)", October 2020

b) KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz"

Additional Documentation:

c) DASY4/5 System Handbook

Methods Applied and Interpretation of Parameters:

- Measurement Conditions: Further details are available from the Validation Report at the end
 of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL: The dipole is mounted with the spacer to position its feed
 point exactly below the center marking of the flat phantom section, with the arms oriented
 parallel to the body axis.
- Feed Point Impedance and Return Loss: These parameters are measured with the dipole
 positioned under the liquid filled phantom. The impedance stated is transformed from the
 measurement at the SMA connector to the feed point. The Return Loss ensures low
 reflected power. No uncertainty required.
- Electrical Delay: One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- SAR measured: SAR measured at the stated antenna input power.
- SAR normalized: SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters: The measured TSL parameters are used to calculate the nominal SAR result.

The reported uncertainty of measurement is stated as the standard uncertainty of Measurement multiplied by the coverage factor k=2, which for a normal distribution Corresponds to a coverage probability of approximately 95%.

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Measurement Conditions

DASY Version	DASY52	52.10.4
Extrapolation	Advanced Extrapolation	
Phantom	Triple Flat Phantom 5.1C	
Distance Dipole Center - TSL	10 mm	with Spacer
Zoom Scan Resolution	dx, dy, dz = 5 mm	
Frequency	1750 MHz ± 1 MHz	

Head TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	40.1	1.37 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	40.0 ± 6 %	1.36 mho/m ± 6 %
Head TSL temperature change during test	<1.0 °C		

SAR result with Head TSL

SAR averaged over 1 cm^3 (1 g) of Head TSL	Condition	
SAR measured	250 mW input power	9.01 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	36.2 W/kg ± 18.8 % (k=2)
SAR averaged over 10 cm^3 (10 g) of Head TSL	Condition	
SAR measured	250 mW input power	4.77 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	19.1 W/kg ± 18.7 % (k=2)

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In Collaboration with S D C ALIBRATION LABORATORY



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Appendix (Additional assessments outside the scope of CNAS L0570)

Antenna Parameters with Head TSL

Impedance, transformed to feed point	49.7Ω+ 2.47jΩ	
Return Loss	- 32.1dB	

General Antenna Parameters and Design

Electrical Delay (one direction)	1.128 ns	
----------------------------------	----------	--

After long term use with 100W radiated power, only a slight warming of the dipole near the feed-point can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals. On some of the dipoles, small end caps are added to the dipole arms in order to improve matching when loaded according to the position as explained in the "Measurement Conditions" paragraph. The SAR data are not affected by this change. The overall dipole length is still according to the Standard. No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feed-point may be damaged.

Additional EUT Data

Manufactured by	SPEAG

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DASY5 Validation Report for Head TSL



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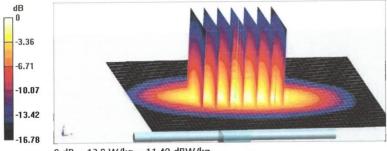
Date: 2023-12-14

Test Laboratory: CTTL, Beijing, China **DUT: Dipole 1750 MHz; Type: D1750V2; Serial: D1750V2 - SN: 1063** Communication System: UID 0, CW; Frequency: 1750 MHz; Duty Cycle: 1:1 Medium parameters used: f = 1750 MHz; $\sigma = 1.362$ S/m; $\varepsilon_r = 40.01$; $\rho = 1000$ kg/m³ Phantom section: Right Section Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY5 Configuration:

- Probe: EX3DV4 SN3617; ConvF(8.4, 8.4, 8.4) @ 1750 MHz; Calibrated: 2023-03-31
- Sensor-Surface: 1.4mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn1556; Calibrated: 2023-01-11
- Phantom: MFP_V5.1C (20deg probe tilt); Type: QD 000 P51 Cx; Serial: 1062
- DASY52 52.10.4(1535); SEMCAD X 14.6.14(7501)

Dipole Calibration/Zoom Scan (7x7x7) (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm Reference Value = 94.11 V/m; Power Drift = -0.01 dB Peak SAR (extrapolated) = 16.7 W/kg SAR(1 g) = 9.01 W/kg; SAR(10 g) = 4.77 W/kg Smallest distance from peaks to all points 3 dB below = 9.5 mm Ratio of SAR at M2 to SAR at M1 = 54.9% Maximum value of SAR (measured) = 13.8 W/kg



0 dB = 13.8 W/kg = 11.40 dBW/kg

Certificate No: 23J02Z80199

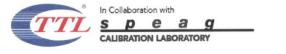
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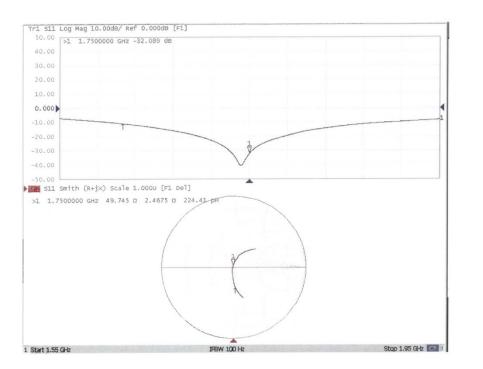








Impedance Measurement Plot for Head TSL



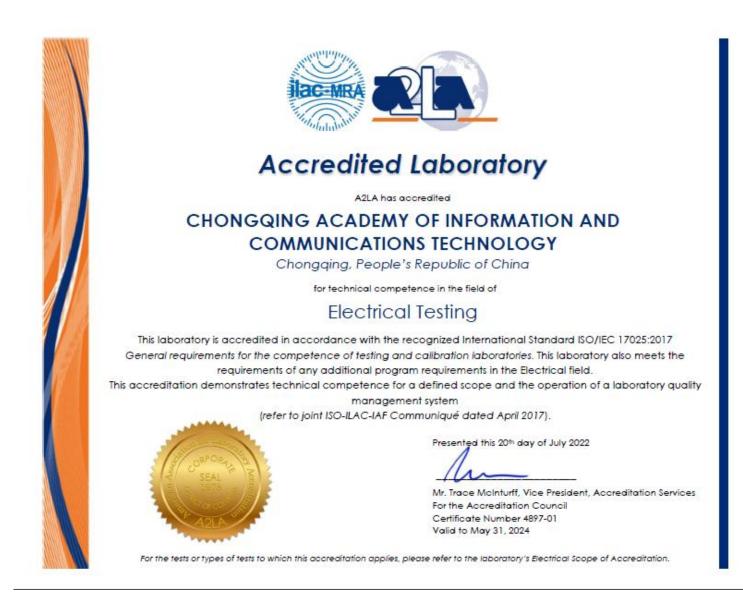
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ANNEX D. Accreditation Certificate



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